



Vincotech

flow 2 MNPC		1200 V / 160 A
Features	• mixed voltage NPC topology • reactive power capability • low inductance layout • Split output • Common collector neutral connection	flow 2 13mm housing
Target Applications	• solar inverter • UPS • Active frontend	Schematic
Types	• 30-FT12NMA160SH-M669F08	

Maximum Ratings

 $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
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Buck Inverse Diode

Repetitive peak reverse voltage	V_{RRM}		1200	V
DC forward current	I_F	$T_j = T_{jmax}$ $T_s = 80^\circ\text{C}$	7	A
Maximum repetitive forward current	I_{FRM}	$t_p = 10 \text{ ms}$	14	A
I^2t -value	I^2t	$T_j = T_{jmax}$	40	A^2s
Power dissipation	P_{tot}	$T_s = 80^\circ\text{C}$	40	W
Maximum Junction Temperature	T_{jmax}		150	$^\circ\text{C}$

Buck Switch

Collector-emitter breakdown voltage	V_{CE}		1200	V
DC collector current	I_C	$T_j = T_{jmax}$ $T_s = 80^\circ\text{C}$	157	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	480	A
Turn off safe operating area		$V_{CE}\text{max} = 1200\text{V}$, $T_{vj} \leq 150^\circ\text{C}$	320	A
Power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80^\circ\text{C}$	398	W
Gate-emitter peak voltage	V_{GE}		± 20	V
Short circuit ratings	t_{SC} V_{CC}	$T_j \leq 150^\circ\text{C}$ $V_{GE} = 15\text{V}$	10 800	μs V
Maximum Junction Temperature	T_{jmax}		175	$^\circ\text{C}$



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Maximum Ratings

 $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
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Buck Diode

Peak Repetitive Reverse Voltage	V_{RRM}		600	V
DC forward current	I_F	$T_j = T_{jmax}$	96	A
Non-repetitive Peak Surge Current	I_{FSM}	t_p limited by T_{jmax}	1200	A
Power dissipation	P_{tot}	$T_j = T_{jmax}$	110	W
Maximum Junction Temperature	T_{jmax}		150	°C

Boost Switch

Collector-emitter breakdown voltage	V_{CE}		600	V
DC collector current	I_C	$T_j = T_{jmax}$	91	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	300	A
Turn off safe operating area		$V_{CE} \leq 600\text{V}, T_j \leq 175^\circ\text{C}$	300	A
Power dissipation	P_{tot}	$T_j = T_{jmax}$	174	W
Gate-emitter peak voltage	V_{GE}		±20	V
Short circuit ratings	t_{SC} V_{CC}	$T_j \leq 150^\circ\text{C}$ $V_{GE} = 15\text{ V}$	6 360	μs V
Maximum Junction Temperature	T_{jmax}		175	°C

Boost Inverse Diode

Peak Repetitive Reverse Voltage	V_{RRM}		600	V
DC forward current	I_F	$T_j = T_{jmax}$	38	A
Maximum repetitive forward current	I_{FRM}	t_p limited by T_{jmax}	60	A
Power dissipation	P_{tot}	$T_j = T_{jmax}$	65	W
Maximum Junction Temperature	T_{jmax}		175	°C

Boost Diode

Peak Repetitive Reverse Voltage	V_{RRM}		1200	V
DC forward current	I_F	$T_j = T_{jmax}$	50	A
Nonrepetitive peak surge current	I_{FRM}	t_p limited by T_{jmax} (Halfwave 1 Phase 60Hz)	650	A
Power dissipation	P_{tot}	$T_j = T_{jmax}$	94	W
Maximum Junction Temperature	T_{jmax}		150	°C

Thermal Properties

Storage temperature	T_{stg}		-40...+125	°C
Operation temperature under switching condition	T_{op}		-40...+(T_{jmax} - 25)	°C

Isolation Properties

Isolation voltage	V_{isol}	DC voltage*	$t_p = 2\text{ s}$	4000	V
		AC voltage	$t_p = 1\text{ min}$	min 12,7	V
Creepage distance				min 12,7	mm
Clearance				>200	mm
Comparative Tracking Index	CTI				

* 100 % tested in production



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Characteristic Values

Parameter	Symbol	Conditions						Value			Unit
		V_{GE} [V]	V_r [V]	I_c [A]	T_j [°C]	Min	Typ	Max			
		V_{GS} [V]	V_{CE} [V]	I_F [A]	I_D [A]						
Buck Inverse Diode											
Forward voltage	V_F			7	25 125	1	1,97 1,65	3,4		V	
Threshold voltage (for power loss calc. only)	V_{to}			7	25 125		1,33 1,01			V	
Slope resistance (for power loss calc. only)	r_t			7	25 125		91 91			mΩ	
Reverse current	I_r		1200		25			0,25		mA	
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$					1,77			K/W	
Buck Switch											
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE} = V_{GE}$		0,006	25	5,2	5,8	6,5		V	
Collector-emitter saturation voltage	V_{CEsat}		15	160	25 125	2	2,02 2,37	2,4		V	
Collector-emitter cut-off current incl. Diode	I_{CES}		0	1200	25			0,02		mA	
Gate-emitter leakage current	I_{GES}		20	0	25			480		nA	
Integrated Gate resistor	R_{gint}						none			Ω	
Turn-on delay time	$t_{d(on)}$	$R_{goff} = 4 \Omega$	$R_{gon} = 4 \Omega$	±15	700	100	25 125	133 135		ns	
Rise time	t_r						25 125	20 23			
Turn-off delay time	$t_{d(off)}$						25 125	225 276			
Fall time	t_f						25 125	38 64			
Turn-on energy loss	E_{on}						25 125	1,80 3,18		mWs	
Turn-off energy loss	E_{off}						25 125	2,52 4,03			
Input capacitance	C_{ies}	$f = 1 \text{ MHz}$		0	25	25		9200			
Output capacitance	C_{oss}							920		pF	
Reverse transfer capacitance	C_{rss}							540			
Gate charge	Q_G							740		nC	
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						0,24		K/W	



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Characteristic Values

Parameter	Symbol	Conditions					Value			Unit			
		V_{GE} [V]	V_r [V]	I_c [A]	I_F [A]	T_j [°C]	Min	Typ	Max				
		V_{GS} [V]	V_{CE} [V]	I_D [A]									
Buck Diode													
Diode forward voltage	V_F			120	25 125		1,47 1,29	1,7		V			
Peak reverse recovery current	I_{RRM}				25 125		127 151			A			
Reverse recovery time	t_{rr}				25 125		40 81			ns			
Reverse recovered charge	Q_{rr}	$R_{gon} = 4 \Omega$	± 15	700 100	25 125 25 125 25 125		3,02 7,13			μC			
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$						12386 3767			A/μs			
Reverse recovered energy	E_{rec}						0,31 1,01			mWs			
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$					0,64			K/W			
Boost Switch													
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{GE} = V_{GE}$		0,0016	25	5	5,8	6,5		V			
Collector-emitter saturation voltage	V_{CESat}		15	100	25 125	1,05	1,58 1,8	1,85		V			
Collector-emitter cut-off incl diode	I_{CES}		0	600	25			0,0052		mA			
Gate-emitter leakage current	I_{GES}		20	0	25			1200		nA			
Integrated Gate resistor	R_{gint}						none			Ω			
Turn-on delay time	$t_{d(on)}$	$R_{goff} = 4 \Omega$ $R_{gon} = 4 \Omega$	± 15	700 100	25 125 25 125 25 125 25 125		103 103						
Rise time	t_r						17 19			ns			
Turn-off delay time	$t_{d(off)}$						158 179						
Fall time	t_f						44 64						
Turn-on energy loss	E_{on}						1,06 1,52			μWs			
Turn-off energy loss	E_{off}						2,48 3,32						
Input capacitance	C_{ies}						6280			pF			
Output capacitance	C_{oss}						400						
Reverse transfer capacitance	C_{rss}						186						
Gate charge	Q_G		15	480	100		620			nC			
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$					0,54			K/W			
Boost Inverse Diode													
Diode forward voltage	V_F			30	25 125	1,00	1,64 1,55	1,95		V			
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$					1,45			K/W			



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Characteristic Values

Parameter	Symbol	Conditions						Value			Unit		
		V_{GE} [V]	V_r [V]	I_c [A]	T_j [$^{\circ}$ C]	Min	Typ	Max					
		V_{GS} [V]	V_{CE} [V]	I_F [A]	I_D [A]								
Boost Diode													
Diode forward voltage	V_F			60	25 125	1,50	2,47 2,11	3,30		V			
Reverse leakage current	I_r		1200		25			200		μ A			
Peak reverse recovery current	I_{RRM}	$R_{gon} = 4 \Omega$	± 15	700	100	25 125	107 142			A			
Reverse recovery time	t_{rr}					25 125	51 69			ns			
Reverse recovered charge	Q_{rr}					25 125	6 13			μ C			
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125	5985 2890			A/ μ s			
Reverse recovery energy	E_{rec}					25 125	1,71 3,61			mWs			
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal grease thickness $\leq 50\text{um}$ $\lambda = 1 \text{ W/mK}$					0,74			K/W			
Thermistor													
Rated resistance	R				25		22000			Ω			
Deviation of R_{100}	$\Delta R/R$	$R_{100} = 1486 \Omega$			100	-5		+5		%			
Power dissipation	P				25		200			mW			
Power dissipation constant					25		2			mW/K			
B-value	$B_{(25/50)}$	Tol. $\pm 3\%$			25		3950			K			
B-value	$B_{(25/100)}$	Tol. $\pm 3\%$			25		3998			K			
Vincotech NTC Reference								B					

Buck Switch

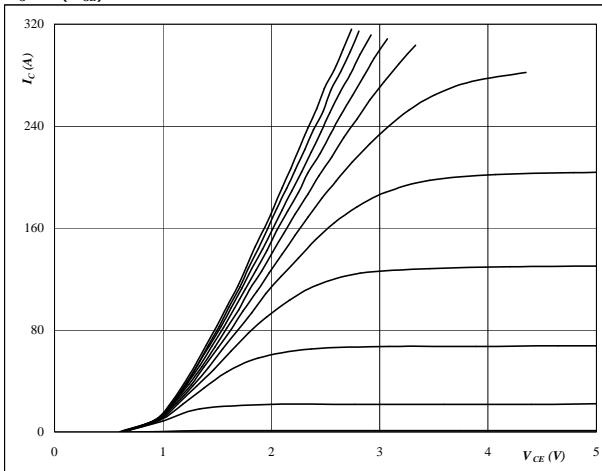
Buck IGBT and Buck FWD

figure 1.

IGBT

Typical output characteristics

$$I_C = f(V_{CE})$$



At

$$t_p = 250 \mu\text{s}$$

$$T_j = 25^\circ\text{C}$$

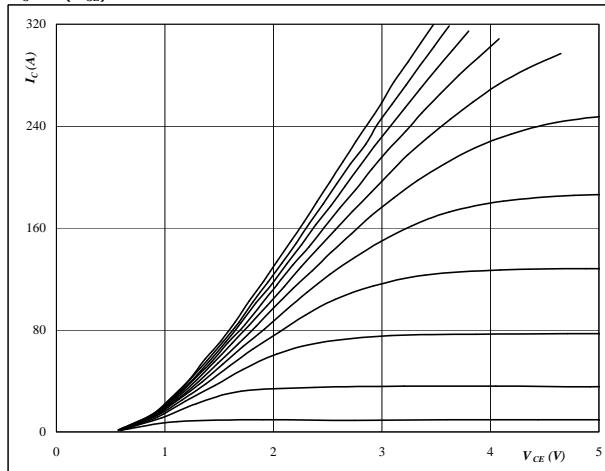
V_{GE} from 7 V to 17 V in steps of 1 V

figure 2.

IGBT

Typical output characteristics

$$I_C = f(V_{CE})$$



At

$$t_p = 250 \mu\text{s}$$

$$T_j = 125^\circ\text{C}$$

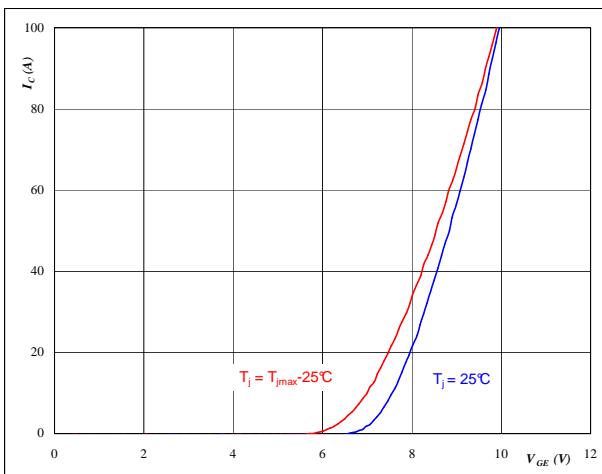
V_{GE} from 7 V to 17 V in steps of 1 V

figure 3.

IGBT

Typical transfer characteristics

$$I_C = f(V_{GE})$$



At

$$t_p = 250 \mu\text{s}$$

$$V_{CE} = 10 \text{ V}$$

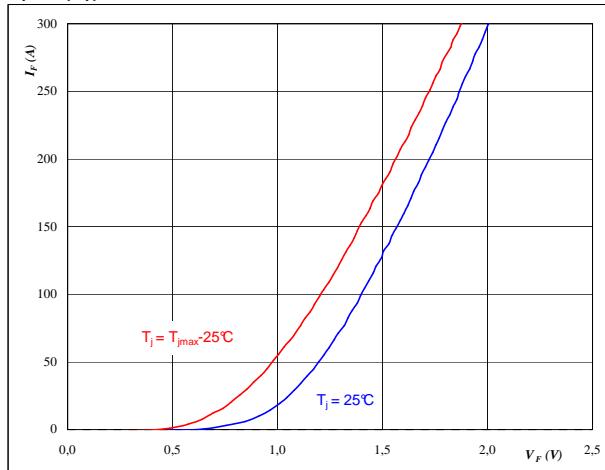
$$T_j = 25/150^\circ\text{C}$$

figure 4.

FWD

Typical FWD forward current as a function of forward voltage

$$I_F = f(V_F)$$



At

$$t_p = 250 \mu\text{s}$$

$$T_j = 25/150^\circ\text{C}$$

Buck Switch

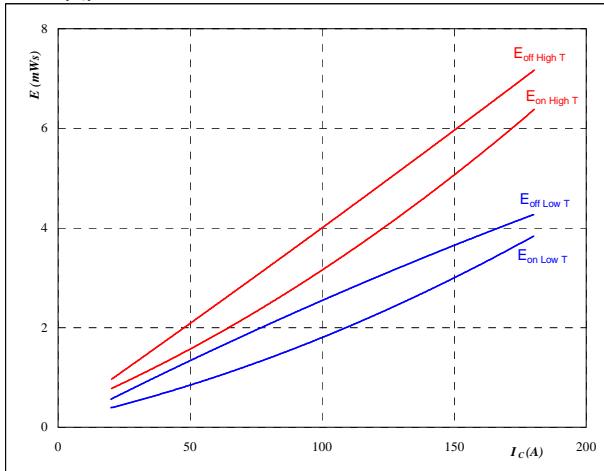
Buck IGBT and Buck FWD

figure 5.

IGBT

**Typical switching energy losses
as a function of collector current**

$$E = f(I_C)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

$$R_{gon} = 4 \text{ } \Omega$$

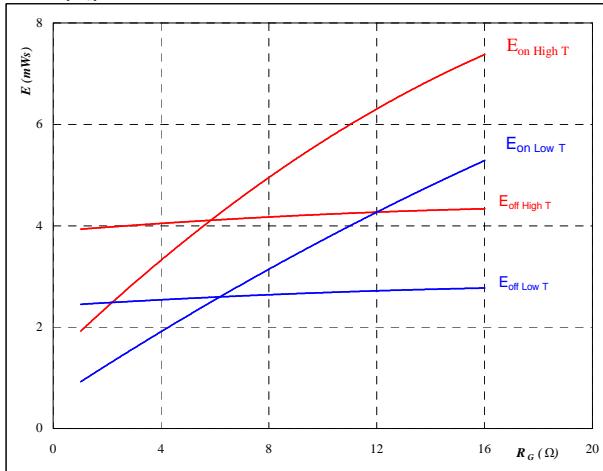
$$R_{goff} = 4 \text{ } \Omega$$

figure 6.

IGBT

**Typical switching energy losses
as a function of gate resistor**

$$E = f(R_G)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

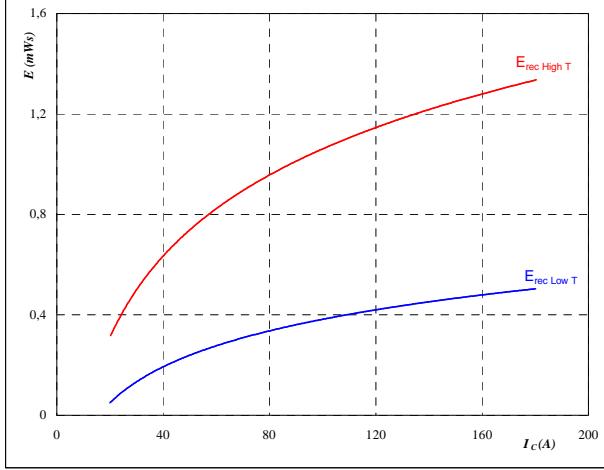
$$I_C = 100 \text{ A}$$

figure 7.

FWD

**Typical reverse recovery energy loss
as a function of collector current**

$$E_{rec} = f(I_C)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

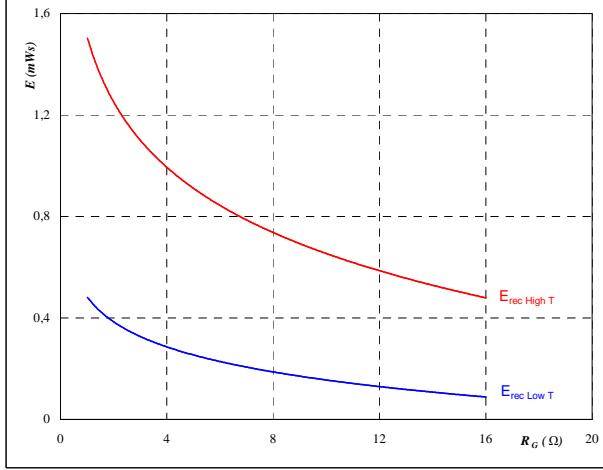
$$R_{gon} = 4 \text{ } \Omega$$

figure 8.

FWD

**Typical reverse recovery energy loss
as a function of gate resistor**

$$E_{rec} = f(R_G)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

$$I_C = 100 \text{ A}$$

Buck Switch

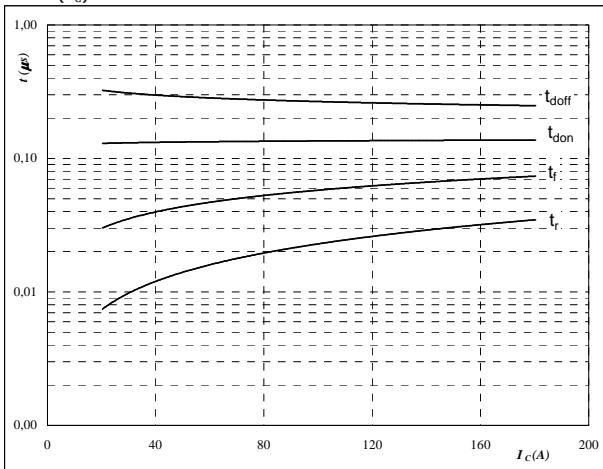
Buck IGBT and Buck FWD

figure 9.

IGBT

Typical switching times as a function of collector current

$$t = f(I_C)$$



With an inductive load at

$$T_j = 125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

$$R_{gon} = 4 \text{ } \Omega$$

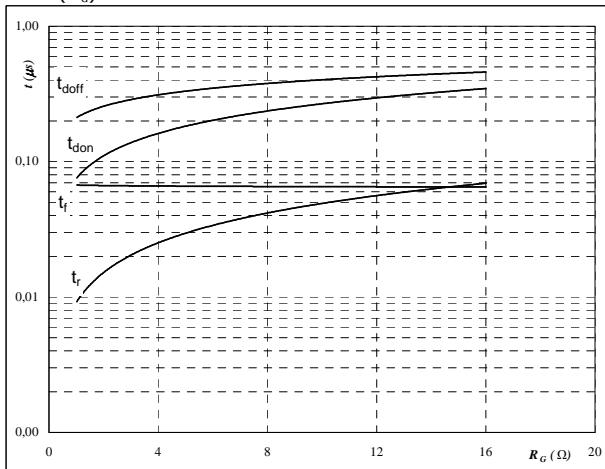
$$R_{goff} = 4 \text{ } \Omega$$

figure 10.

IGBT

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



With an inductive load at

$$T_j = 125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

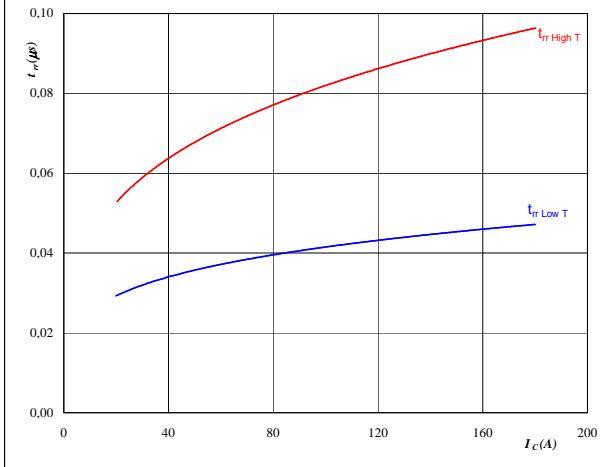
$$I_C = 100 \text{ A}$$

figure 11.

FWD

Typical reverse recovery time as a function of collector current

$$t_{rr} = f(I_c)$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

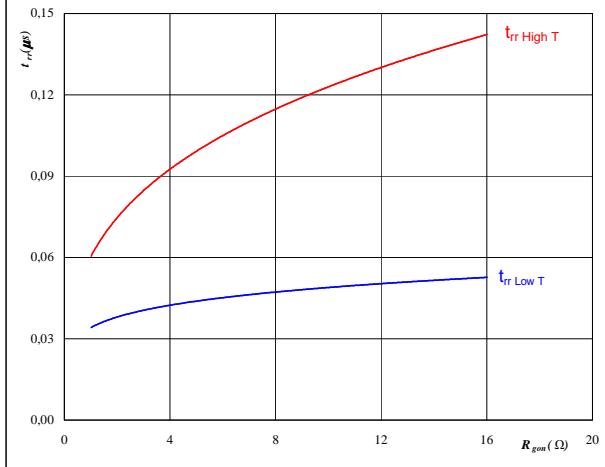
$$R_{gon} = 4 \text{ } \Omega$$

figure 12.

FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$$t_{rr} = f(R_{gon})$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_R = 350 \text{ V}$$

$$I_F = 100 \text{ A}$$

$$V_{GE} = \pm 15 \text{ V}$$

Buck Switch

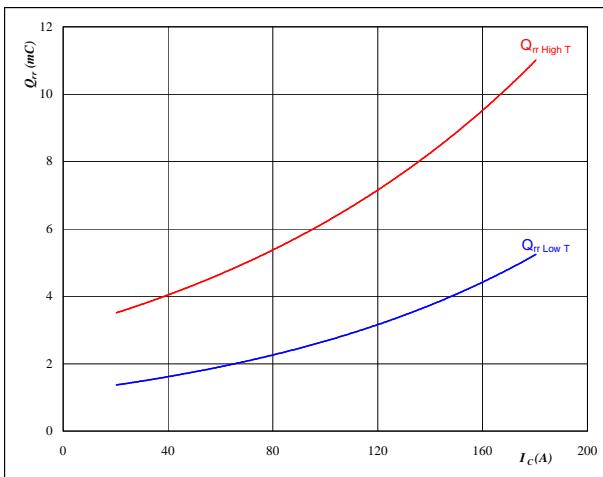
Buck IGBT and Buck FWD

figure 13.

FWD

Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_C)$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

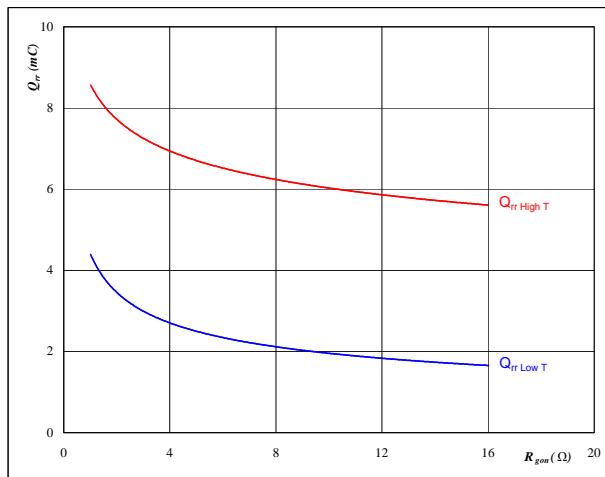
$$R_{gon} = 4 \Omega$$

figure 14.

FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$$Q_{rr} = f(R_{gon})$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_R = 350 \text{ V}$$

$$I_F = 100 \text{ A}$$

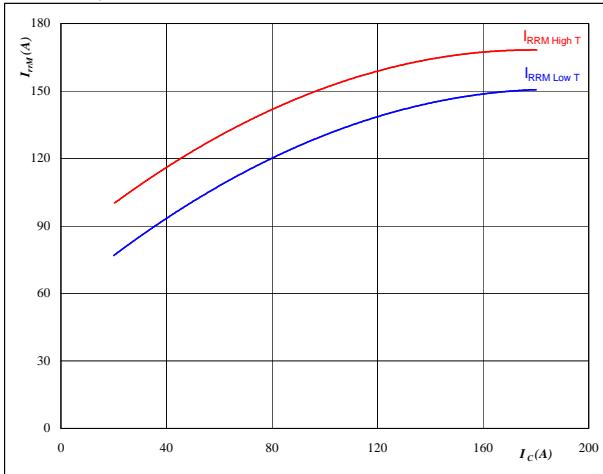
$$V_{GE} = \pm 15 \text{ V}$$

figure 15.

FWD

Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_C)$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

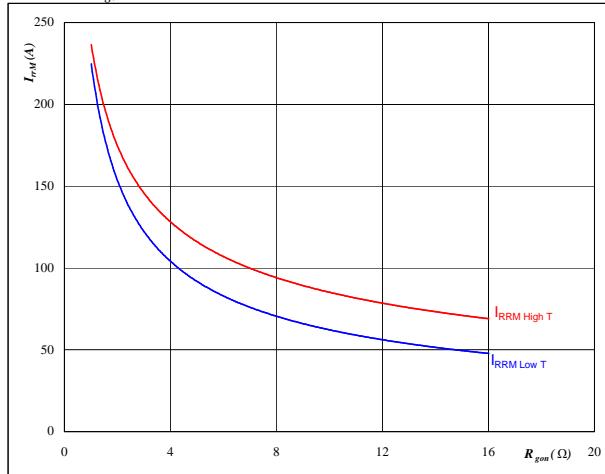
$$R_{gon} = 4 \Omega$$

figure 16.

FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_R = 350 \text{ V}$$

$$I_F = 100 \text{ A}$$

$$V_{GE} = \pm 15 \text{ V}$$



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Buck Switch

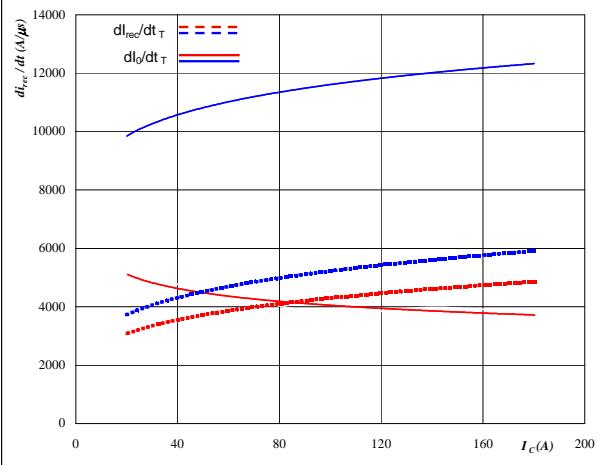
Buck IGBT and Buck FWD

figure 17.

FWD

**Typical rate of fall of forward
and reverse recovery current as a
function of collector current**

$$dI_0/dt, dI_{rec}/dt = f(I_c)$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

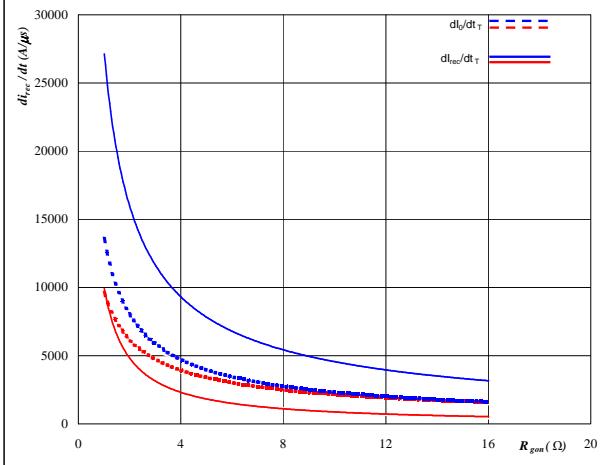
$$R_{gon} = 4 \Omega$$

figure 18.

FWD

**Typical rate of fall of forward
and reverse recovery current as a
function of IGBT turn on gate resistor**

$$dI_0/dt, dI_{rec}/dt = f(R_{gon})$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_R = 350 \text{ V}$$

$$I_F = 100 \text{ A}$$

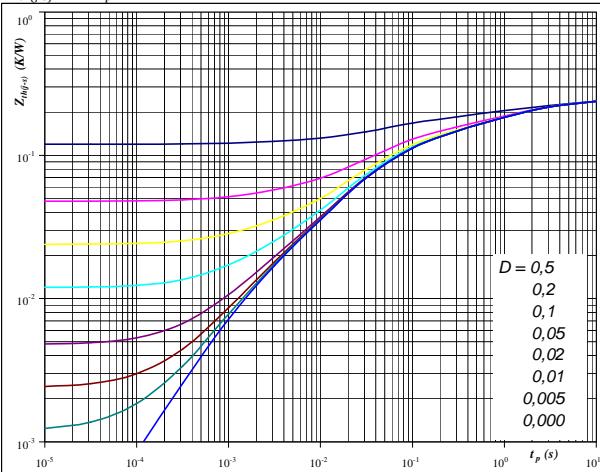
$$V_{GE} = \pm 15 \text{ V}$$

figure 19.

IGBT

**IGBT transient thermal impedance
as a function of pulse width**

$$Z_{th(j-s)} = f(t_p)$$



At

$$D = t_p / T$$

$$R_{th(j-s)} = 0.24 \text{ K/W}$$

IGBT thermal model values

$$R \text{ (K/W)} \quad \text{Tau (s)}$$

$$8.15E-02 \quad 2.26E+00$$

$$5.67E-02 \quad 2.93E-01$$

$$7.19E-02 \quad 4.58E-02$$

$$2.05E-02 \quad 1.26E-02$$

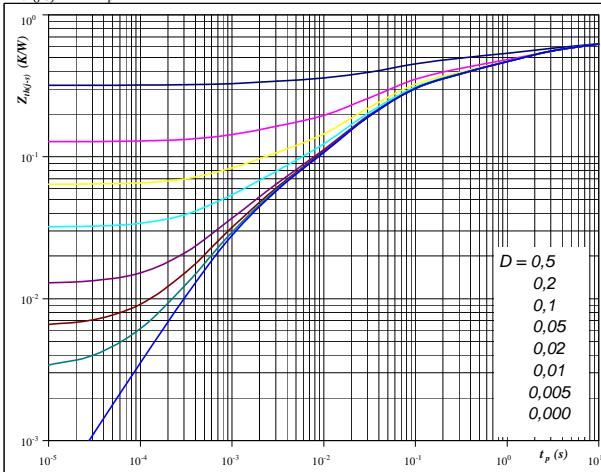
$$7.97E-03 \quad 1.53E-03$$

figure 20.

FWD

**FWD transient thermal impedance
as a function of pulse width**

$$Z_{th(j-s)} = f(t_p)$$



At

$$D = t_p / T$$

$$R_{th(j-s)} = 0.64 \text{ K/W}$$

FWD thermal model values

$$R \text{ (K/W)} \quad \text{Tau (s)}$$

$$1.73E-01 \quad 3.90E+00$$

$$1.15E-01 \quad 8.45E-01$$

$$8.15E-02 \quad 1.79E-01$$

$$1.95E-01 \quad 4.20E-02$$

$$3.86E-02 \quad 9.89E-03$$

$$3.49E-02 \quad 1.28E-03$$



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Buck Switch

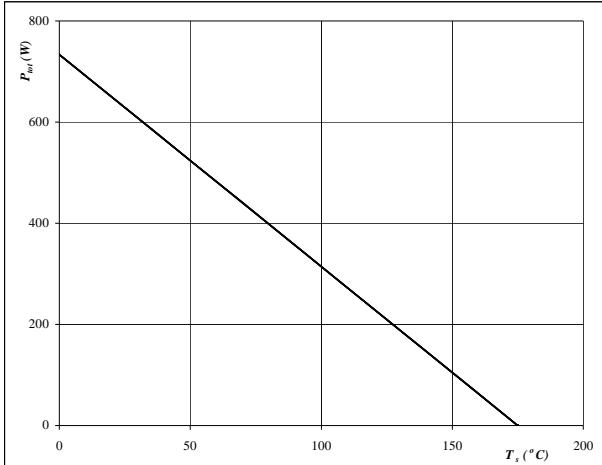
Buck IGBT and Buck FWD

figure 21.

IGBT

**Power dissipation as a
function of heatsink temperature**

$$P_{\text{tot}} = f(T_s)$$



At

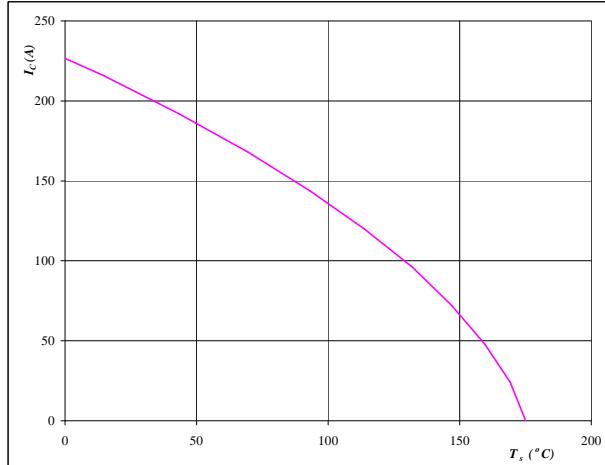
$$T_j = 175 \text{ } ^\circ\text{C}$$

figure 22.

IGBT

**Collector current as a
function of heatsink temperature**

$$I_C = f(T_s)$$



At

$$T_j = 175 \text{ } ^\circ\text{C}$$

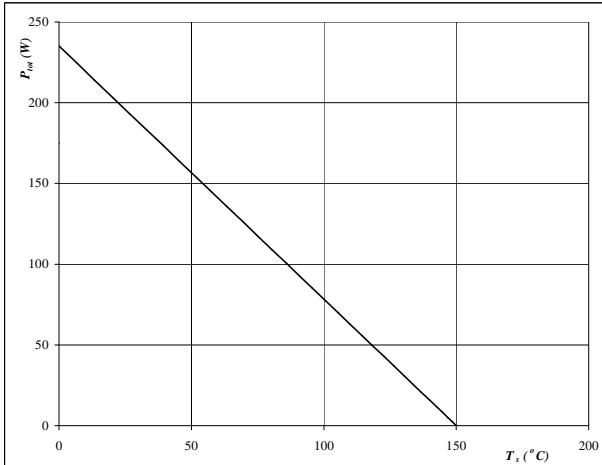
$$V_{GE} = 15 \text{ V}$$

figure 23.

FWD

**Power dissipation as a
function of heatsink temperature**

$$P_{\text{tot}} = f(T_s)$$



At

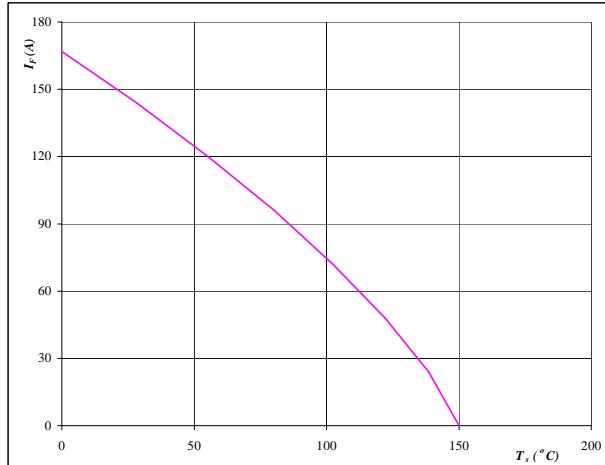
$$T_j = 150 \text{ } ^\circ\text{C}$$

figure 24.

FWD

**Forward current as a
function of heatsink temperature**

$$I_F = f(T_s)$$



At

$$T_j = 150 \text{ } ^\circ\text{C}$$

Buck Switch

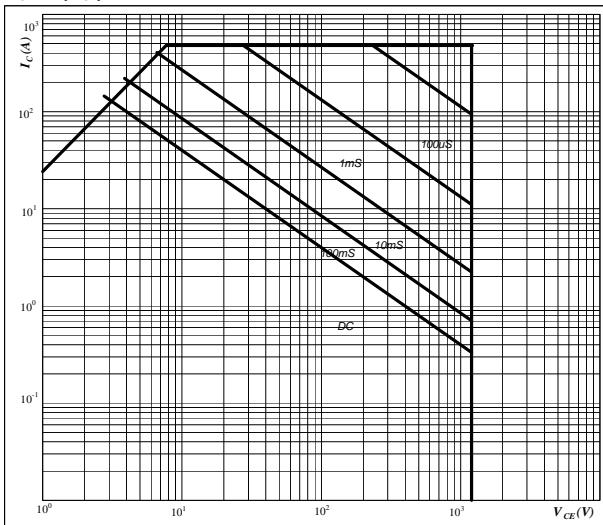
Buck IGBT and Buck FWD

figure 25.

IGBT

**Safe operating area as a function
of collector-emitter voltage**

$$I_C = f(V_{CE})$$



At

$D =$ single pulse

$T_s =$ 80 °C

$V_{GE} = \pm 15$ V

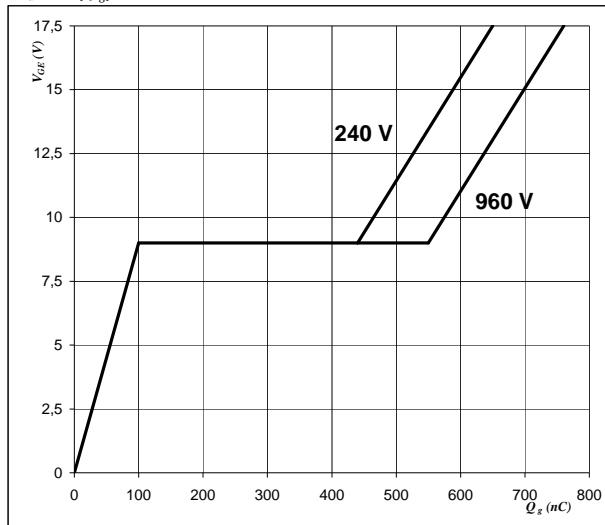
$T_j = T_{jmax}$

figure 26.

IGBT

Gate voltage vs Gate charge

$$V_{GE} = f(Q_g)$$



At

$I_D = 160$ A

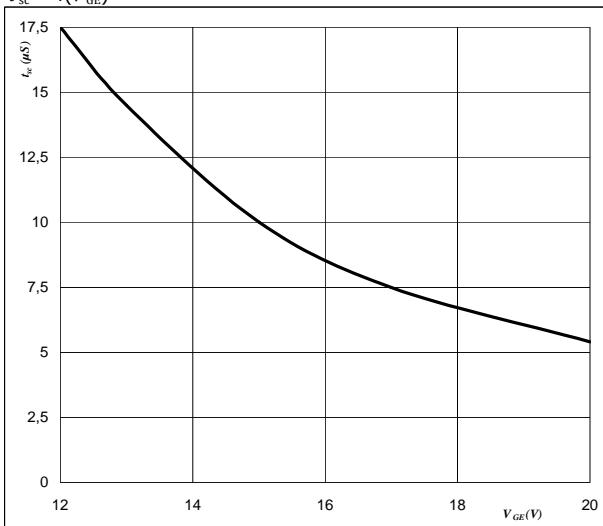
$T_j = 25$ °C

figure 27.

IGBT

**Short circuit withstand time as a function of
gate-emitter voltage**

$$t_{sc} = f(V_{GE})$$



At

$V_{CE} = 1200$ V

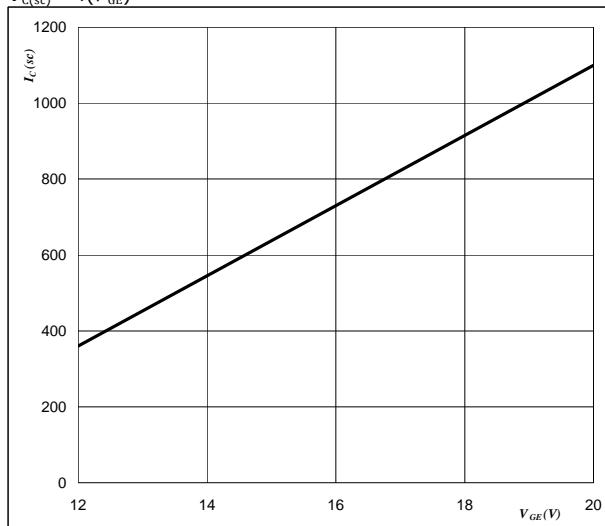
$T_j \leq 175$ °C

figure 28.

IGBT

**Typical short circuit collector current as a function of
gate-emitter voltage**

$$I_{C(sc)} = f(V_{GE})$$



At

$V_{CE} \leq 1200$ V

$T_j = 175$ °C



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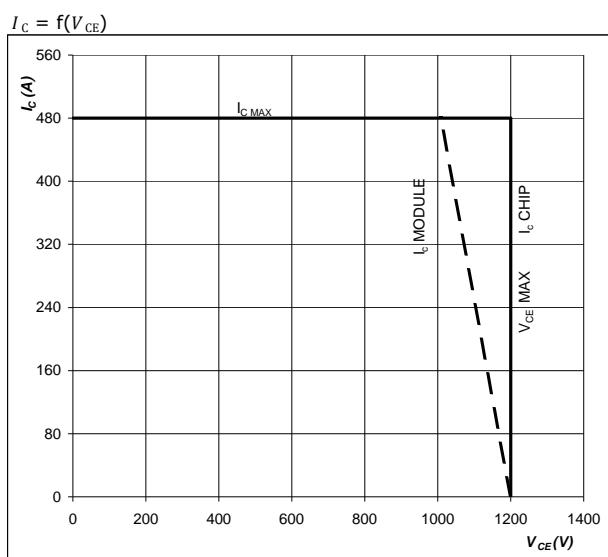
Buck Switch

Buck IGBT and Buck FWD

figure 29.

IGBT

Reverse bias safe operating area



At

$$T_j = T_{jmax} - 25 \text{ } ^\circ\text{C}$$

$$U_{ccminus} = U_{ccplus}$$

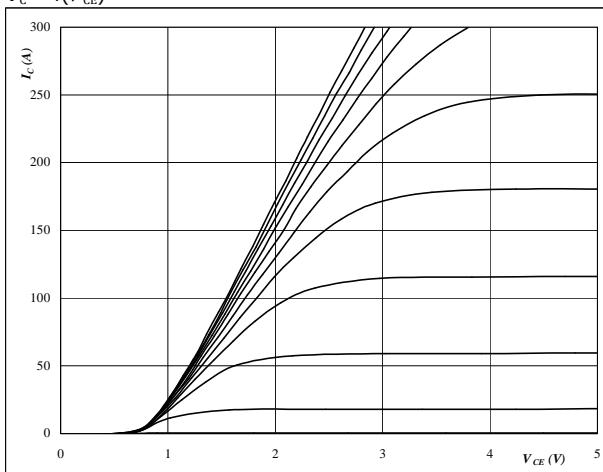
Switching mode : 3 level switching

Boost Switch

Boost IGBT and Boost FWD

figure 1.
IGBT
Typical output characteristics

$$I_C = f(V_{CE})$$


At

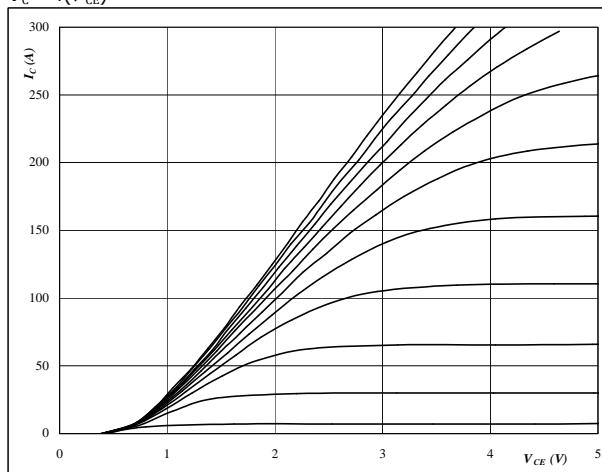
$$t_p = 250 \mu\text{s}$$

$$T_j = 25^\circ\text{C}$$

 V_{GE} from 7 V to 17 V in steps of 1 V

figure 2.
IGBT
Typical output characteristics

$$I_C = f(V_{CE})$$


At

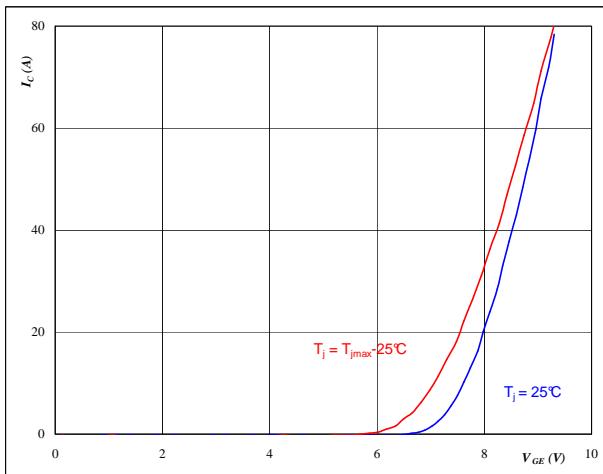
$$t_p = 250 \mu\text{s}$$

$$T_j = 150^\circ\text{C}$$

 V_{GE} from 7 V to 17 V in steps of 1 V

figure 3.
IGBT
Typical transfer characteristics

$$I_C = f(V_{GE})$$


At

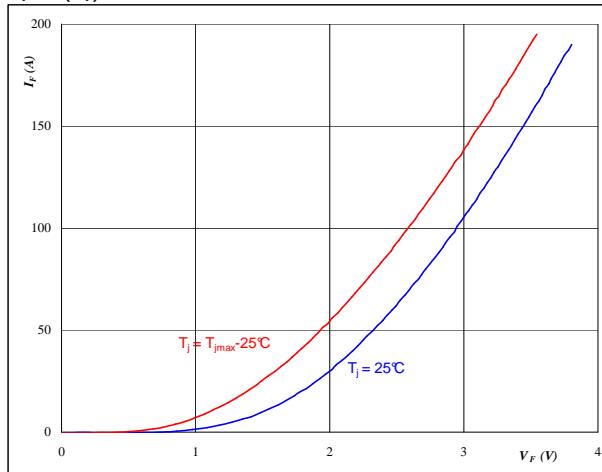
$$t_p = 250 \mu\text{s}$$

$$V_{CE} = 10 \text{ V}$$

$$T_j = 25/150^\circ\text{C}$$

figure 4.
FWD
Typical FWD forward current as a function of forward voltage

$$I_F = f(V_F)$$


At

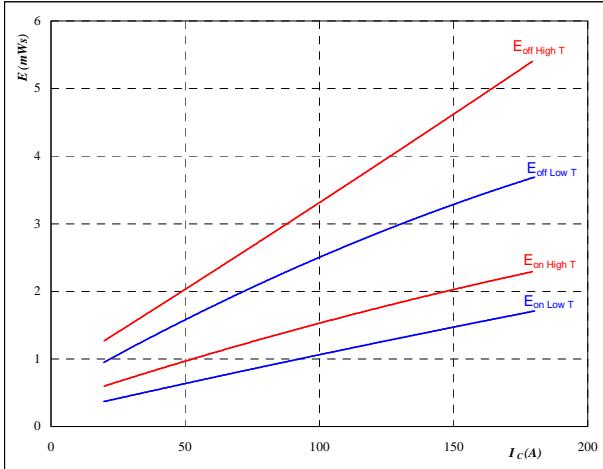
$$t_p = 250 \mu\text{s}$$

$$T_j = 25/150^\circ\text{C}$$

Boost Switch

Boost IGBT and Boost FWD
figure 5.
IGBT
**Typical switching energy losses
as a function of collector current**

$$E = f(I_c)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

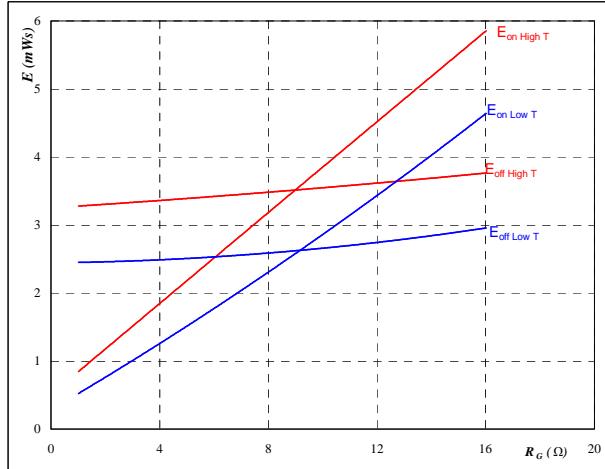
$$V_{GE} = \pm 15 \text{ V}$$

$$R_{gon} = 4 \text{ } \Omega$$

$$R_{goff} = 4 \text{ } \Omega$$

figure 6.
IGBT
**Typical switching energy losses
as a function of gate resistor**

$$E = f(R_G)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

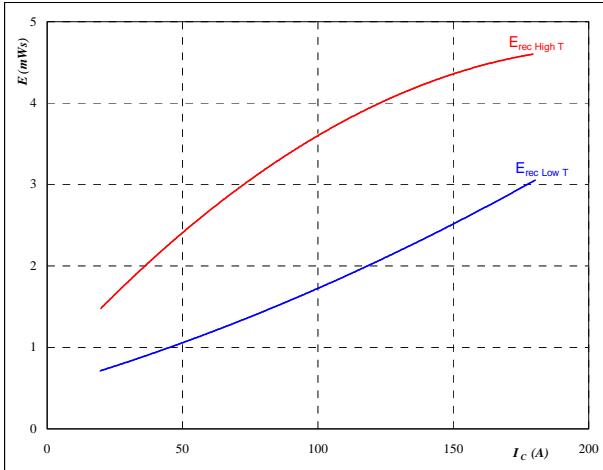
$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

$$I_c = 100 \text{ A}$$

figure 7.
FWD
**Typical reverse recovery energy loss
as a function of collector current**

$$E_{rec} = f(I_c)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

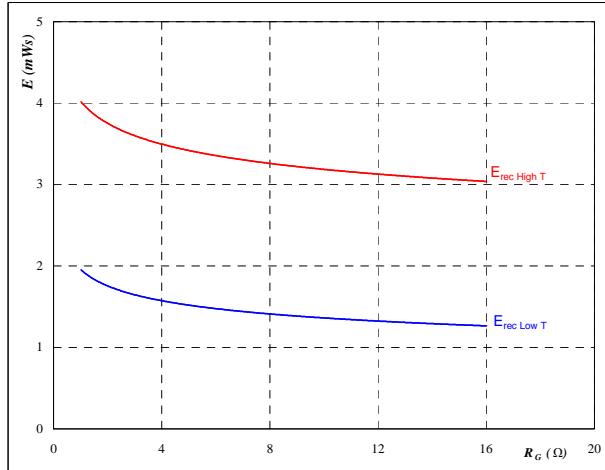
$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

$$R_{gon} = 4 \text{ } \Omega$$

figure 8.
FWD
**Typical reverse recovery energy loss
as a function of gate resistor**

$$E_{rec} = f(R_G)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

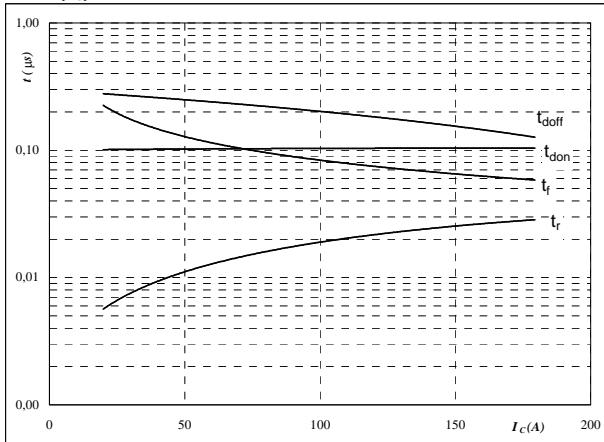
$$I_c = 100 \text{ A}$$

Boost Switch

Boost IGBT and Boost FWD

figure 9.
IGBT
Typical switching times as a function of collector current

$$t = f(I_c)$$

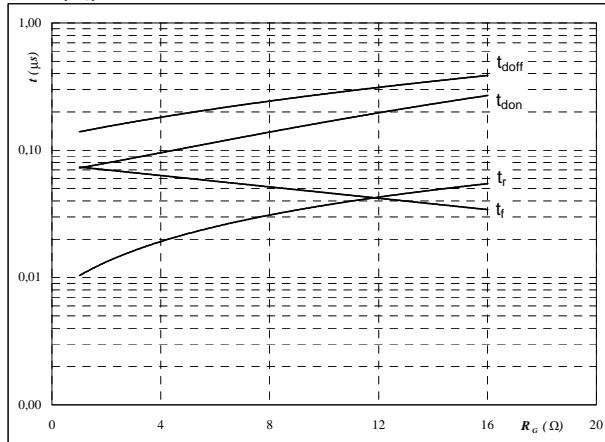


With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	4	Ω
$R_{goff} =$	4	Ω

figure 10.
IGBT
Typical switching times as a function of gate resistor

$$t = f(R_g)$$

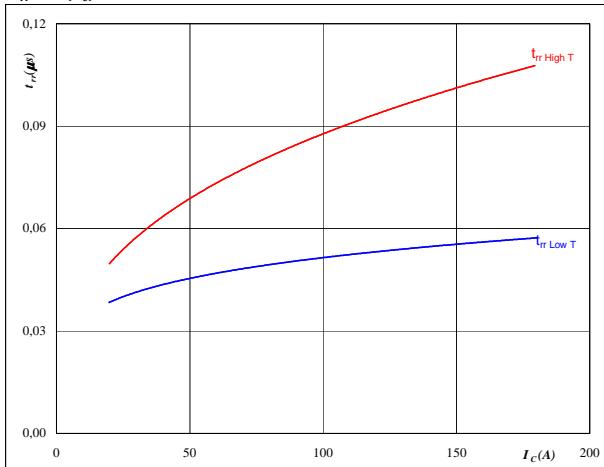


With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$I_c =$	100	A

figure 11.
FWD
Typical reverse recovery time as a function of collector current

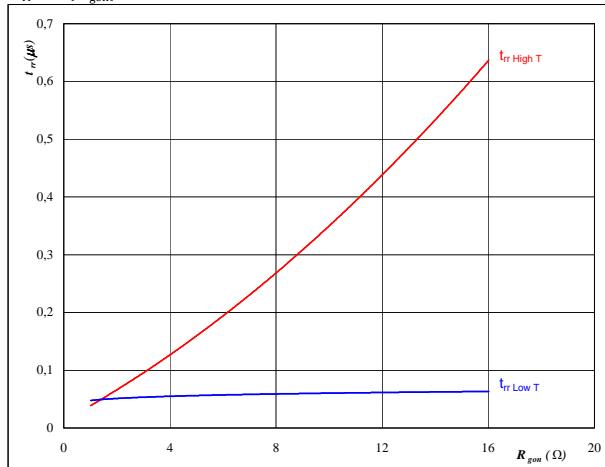
$$t_{rr} = f(I_c)$$


At

$T_j =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	4,0	Ω

figure 12.
FWD
Typical reverse recovery time as a function of IGBT turn on gate resistor

$$t_{rr} = f(R_{gon})$$


At

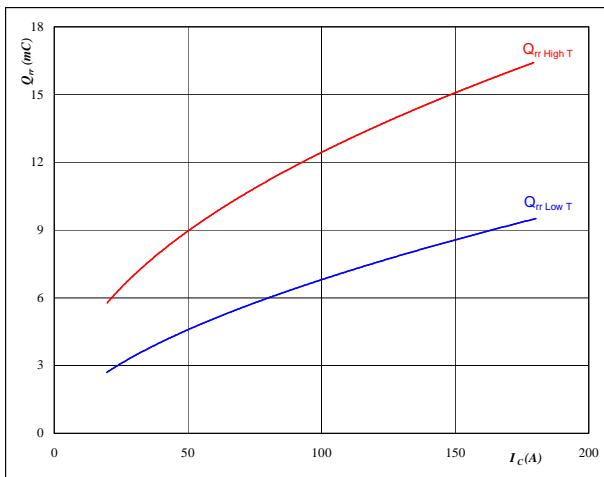
$T_j =$	25/125	°C
$V_R =$	350	V
$I_F =$	100	A
$V_{GE} =$	±15	V

Boost Switch

Boost IGBT and Boost FWD

figure 13.
FWD
Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_C)$$


At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

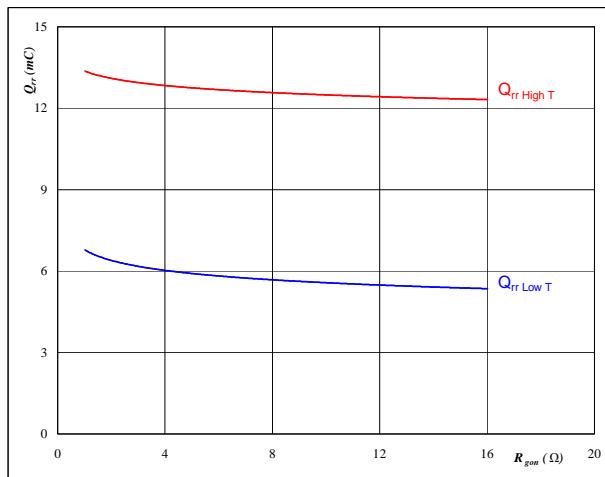
$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

$$R_{gon} = 4 \Omega$$

figure 14.
FWD
Typical reverse recovery charge as a function of IGBT turn on gate resistor

$$Q_{rr} = f(R_{gon})$$


At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

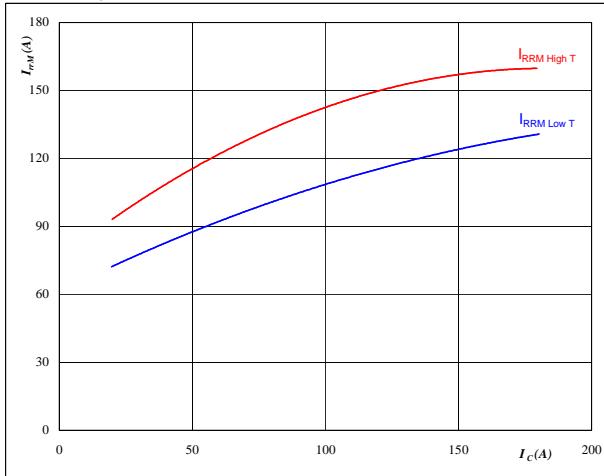
$$V_R = 350 \text{ V}$$

$$I_F = 100 \text{ A}$$

$$V_{GE} = \pm 15 \text{ V}$$

figure 15.
FWD
Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_C)$$


At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

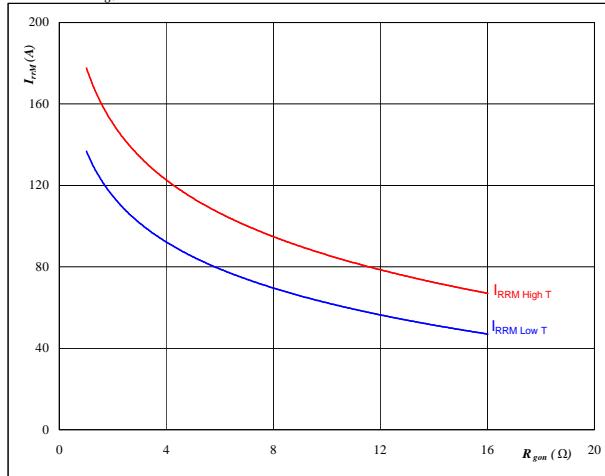
$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

$$R_{gon} = 4 \Omega$$

figure 16.
FWD
Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$


At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_R = 350 \text{ V}$$

$$I_F = 100 \text{ A}$$

$$V_{GE} = \pm 15 \text{ V}$$



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Boost Switch

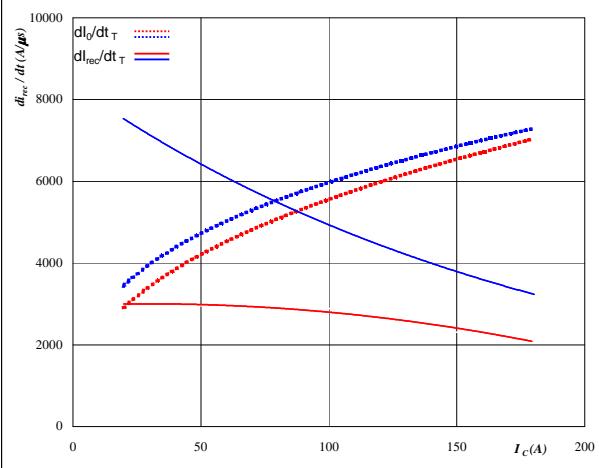
Boost IGBT and Boost FWD

figure 17.

FWD

**Typical rate of fall of forward
and reverse recovery current as a
function of collector current**

$$dI_0/dt, dI_{rec}/dt = f(I_c)$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{CE} = 350 \text{ V}$$

$$V_{GE} = \pm 15 \text{ V}$$

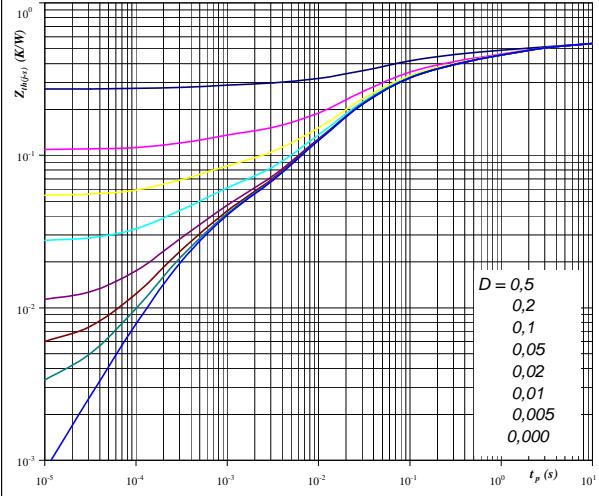
$$R_{gon} = 4 \Omega$$

figure 19.

IGBT

**IGBT transient thermal impedance
as a function of pulse width**

$$Z_{th(j-s)} = f(t_p)$$



At

$$D = t_p / T$$

$$R_{th(j-s)} = 0.54 \text{ K/W}$$

IGBT thermal model values

$$R \text{ (K/W)} \quad \text{Tau (s)}$$

$$1,12E-01 \quad 2,87E+00$$

$$8,79E-02 \quad 4,59E-01$$

$$1,16E-01 \quad 9,51E-02$$

$$1,70E-01 \quad 2,49E-02$$

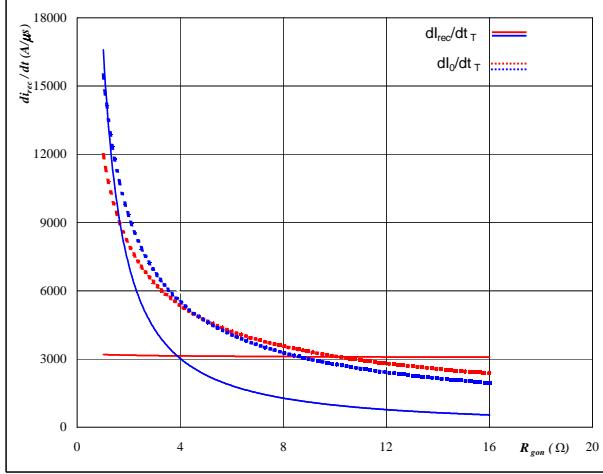
$$3,03E-02 \quad 4,36E-03$$

figure 18.

FWD

**Typical rate of fall of forward
and reverse recovery current as a
function of IGBT turn on gate resistor**

$$dI_0/dt, dI_{rec}/dt = f(R_{gon})$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_R = 350 \text{ V}$$

$$I_F = 100 \text{ A}$$

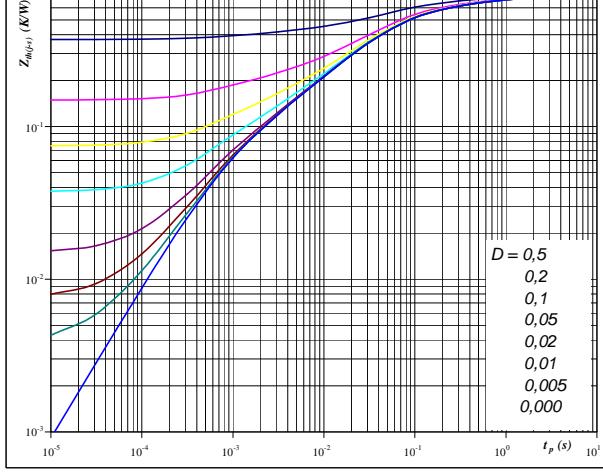
$$V_{GE} = \pm 15 \text{ V}$$

figure 20.

FWD

**FWD transient thermal impedance
as a function of pulse width**

$$Z_{th(j-s)} = f(t_p)$$



Boost Switch

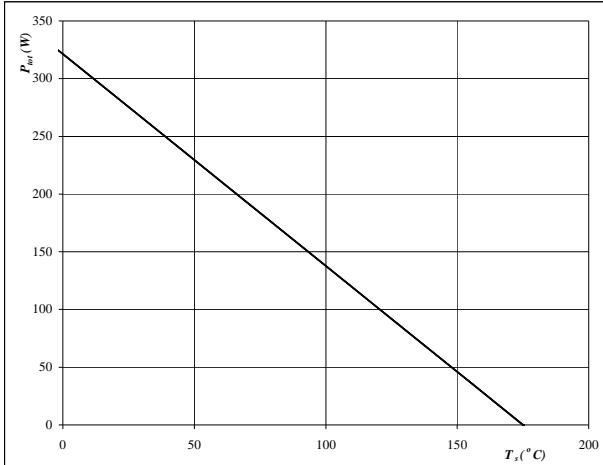
Boost IGBT and Boost FWD

figure 21.

IGBT

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_s)$$



At

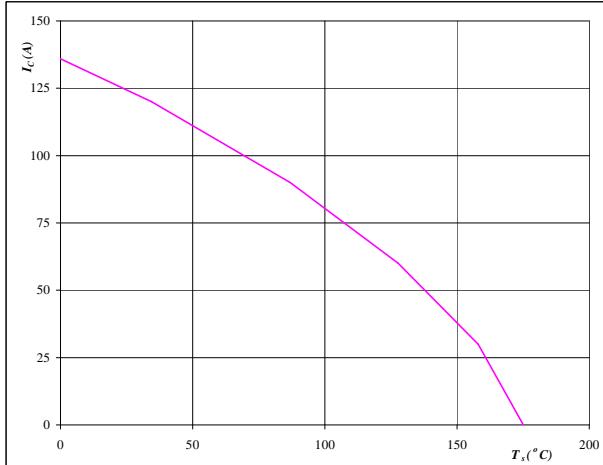
$$T_j = 175 \text{ } ^\circ\text{C}$$

figure 22.

IGBT

Collector current as a function of heatsink temperature

$$I_C = f(T_s)$$



At

$$T_j = 175 \text{ } ^\circ\text{C}$$

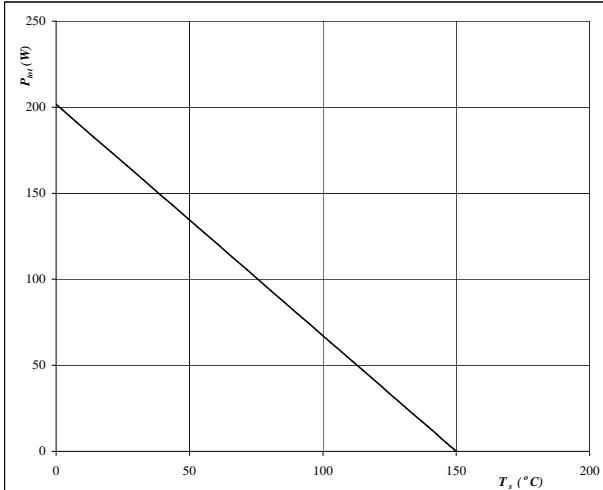
$$V_{GE} = 15 \text{ V}$$

figure 23.

FWD

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_s)$$



At

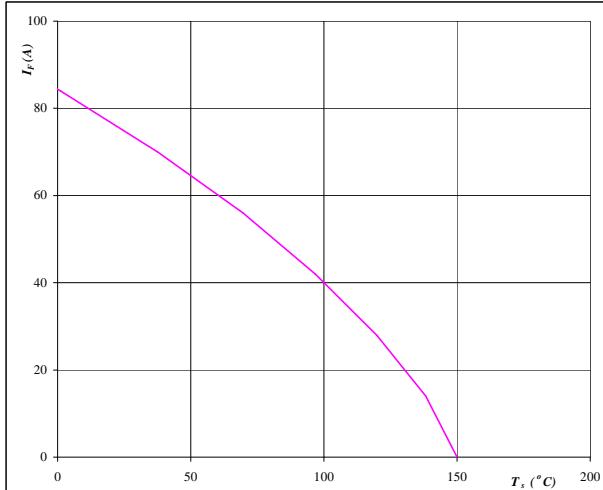
$$T_j = 150 \text{ } ^\circ\text{C}$$

figure 24.

FWD

Forward current as a function of heatsink temperature

$$I_F = f(T_s)$$



At

$$T_j = 150 \text{ } ^\circ\text{C}$$



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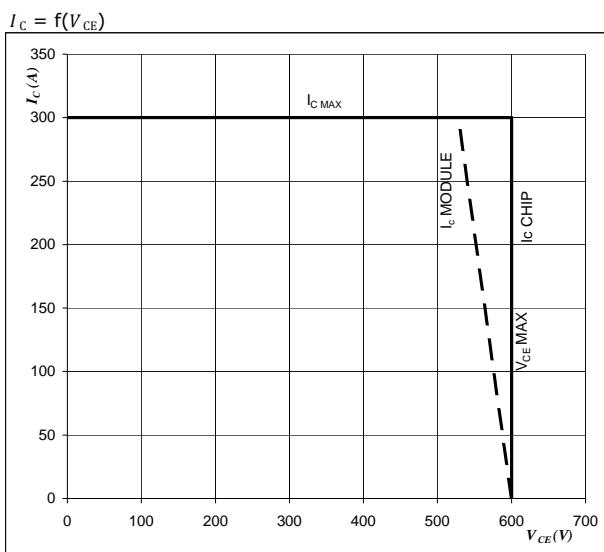
Boost Switch

Boost IGBT

figure 25.

IGBT

Reverse bias safe operating area



At

$$T_j = T_{jmax} - 25 \quad ^\circ\text{C}$$

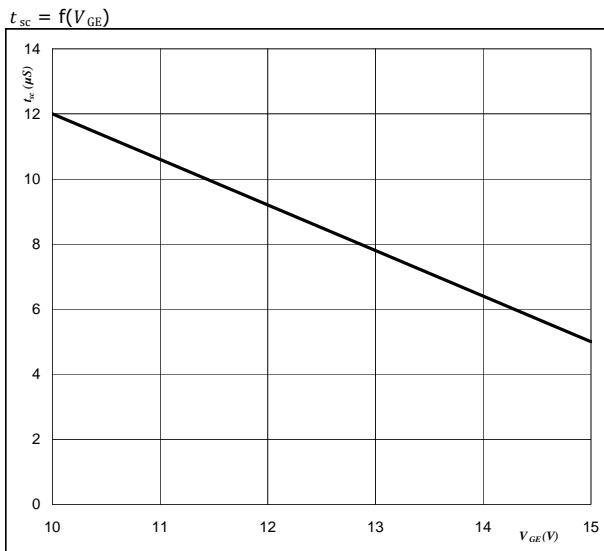
$$U_{ccminus} = U_{ccplus}$$

Switching mode : 3 level switching

figure 27.

IGBT

Short circuit withstand time as a function of gate-emitter voltage



At

$$V_{CE} = 600 \quad \text{V}$$

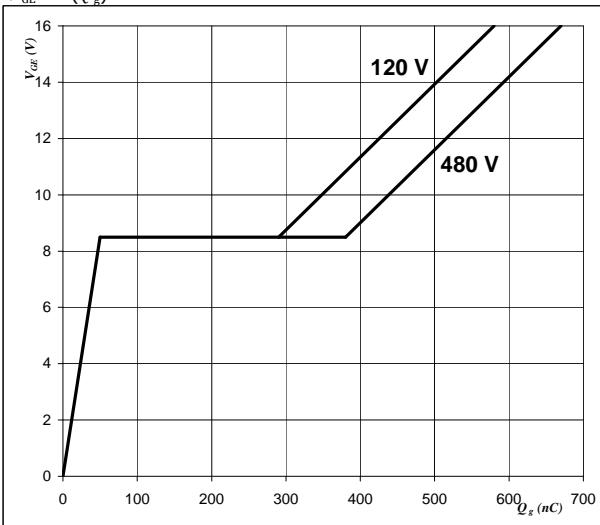
$$T_j \leq 150 \quad ^\circ\text{C}$$

figure 26.

IGBT

Gate voltage vs Gate charge

$V_{GE} = f(Q_g)$



At

$$I_D = 100 \quad \text{A}$$

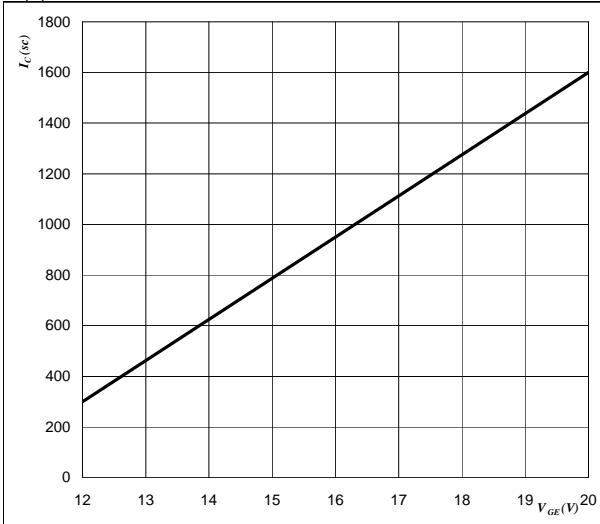
$$T_j = 25 \quad ^\circ\text{C}$$

figure 28.

IGBT

Typical short circuit collector current as a function of gate-emitter voltage

$I_{C(sc)} = f(V_{GE})$



At

$$V_{CE} \leq 400 \quad \text{V}$$

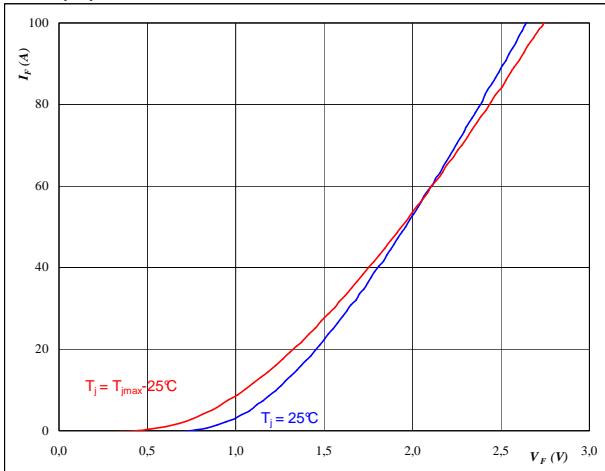
$$T_j = 125 \quad ^\circ\text{C}$$

Boost Inverse Diode

figure 25.
Boost Inverse Diode

Typical FWD forward current as a function of forward voltage

$$I_F = f(V_F)$$

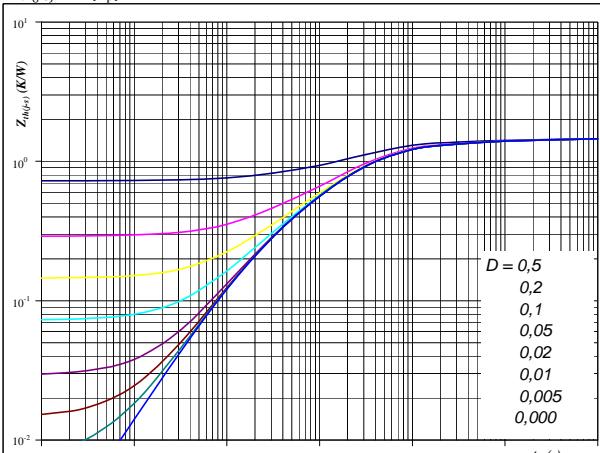

At

$$t_p = 250 \mu\text{s}$$

figure 26.
Boost Inverse Diode

FWD transient thermal impedance as a function of pulse width

$$Z_{\text{th(j-s)}} = f(t_p)$$


At

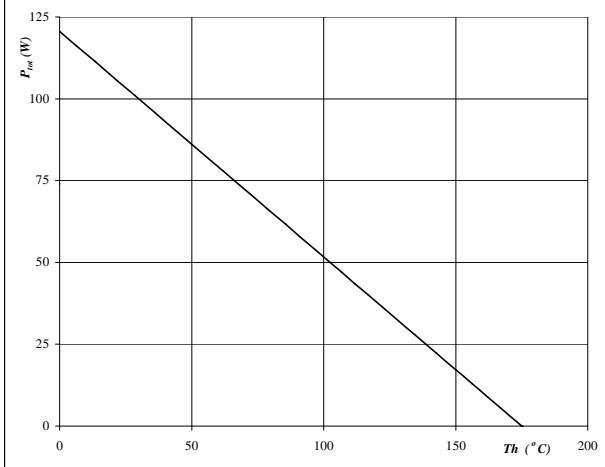
$$D = t_p / T$$

$$R_{\text{th(j-s)}} = 1,45 \text{ K/W}$$

figure 27.
Boost Inverse Diode

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_h)$$

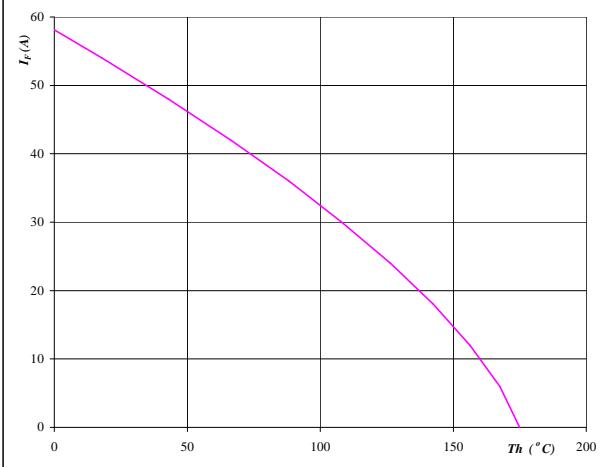

At

$$T_j = 175^{\circ}\text{C}$$

figure 28.
Boost Inverse Diode

Forward current as a function of heatsink temperature

$$I_F = f(T_s)$$


At

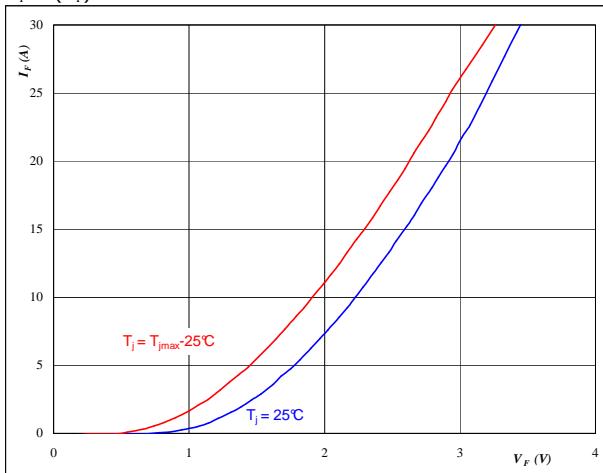
$$T_j = 175^{\circ}\text{C}$$

Buck Inverse Diode

figure 1.**Buck Inverse Diode**

Typical FWD forward current as a function of forward voltage

$$I_F = f(V_F)$$

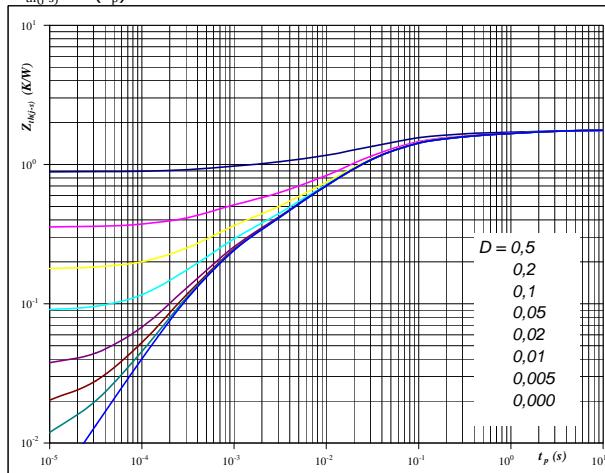
**At**

$$t_p = 250 \mu\text{s}$$

figure 2.**Buck Inverse Diode**

FWD transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$

**At**

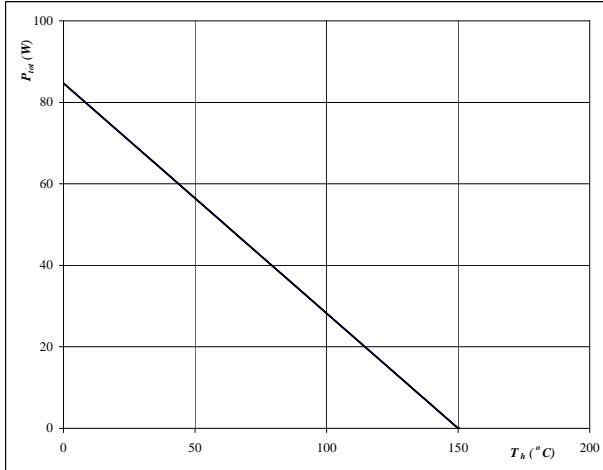
$$D = t_p / T$$

$$R_{th(j-s)} = 1,77 \text{ K/W}$$

figure 3.**Buck Inverse Diode**

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

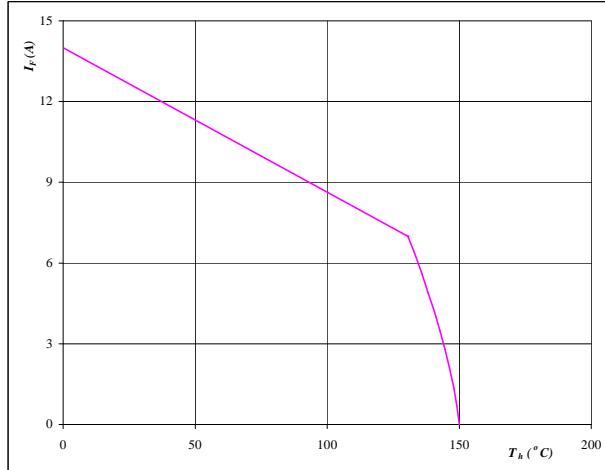
**At**

$$T_j = 150 \text{ °C}$$

figure 4.**Buck Inverse Diode**

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$

**At**

$$T_j = 150 \text{ °C}$$



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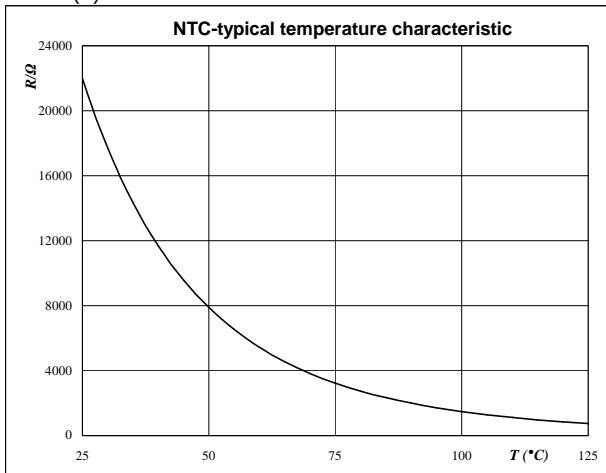
Thermistor

figure 1.

Thermistor

**Typical NTC characteristic
as a function of temperature**

$$R_T = f(T)$$



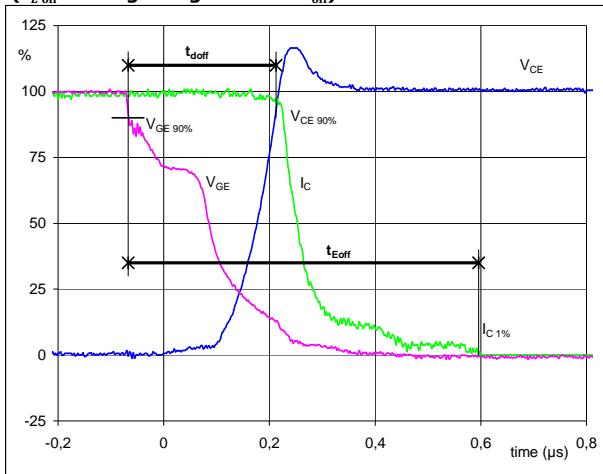
Switching Definitions Buck

General conditions

T_j	= 125 °C
R_{gon}	= 4 Ω
R_{goff}	= 4 Ω

figure 1.**Buck IGBT**

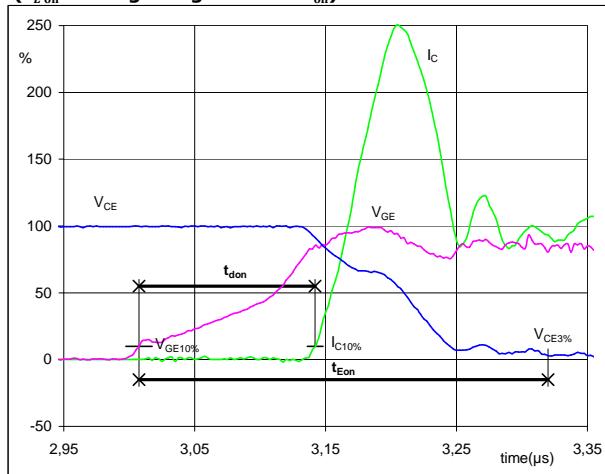
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
 $(t_{Eoff} = \text{integrating time for } E_{off})$



$V_{GE}(0\%) = -15$ V
 $V_{GE}(100\%) = 15$ V
 $V_C(100\%) = 700$ V
 $I_C(100\%) = 100$ A
 $t_{doff} = 0,28$ μs
 $t_{Eoff} = 0,66$ μs

figure 2.**Buck IGBT**

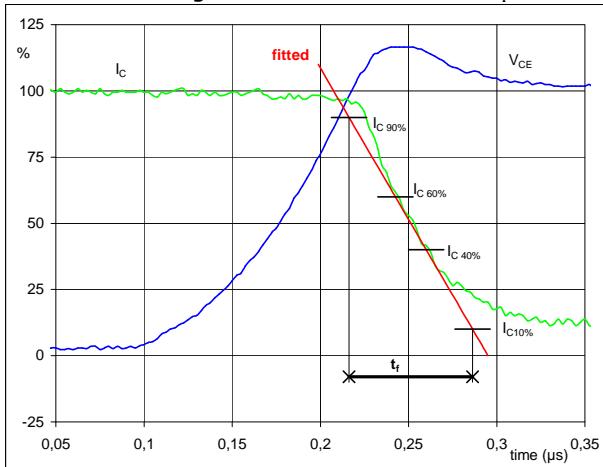
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
 $(t_{Eon} = \text{integrating time for } E_{on})$



$V_{GE}(0\%) = -15$ V
 $V_{GE}(100\%) = 15$ V
 $V_C(100\%) = 700$ V
 $I_C(100\%) = 100$ A
 $t_{don} = 0,14$ μs
 $t_{Eon} = 0,31$ μs

figure 3.**Buck IGBT**

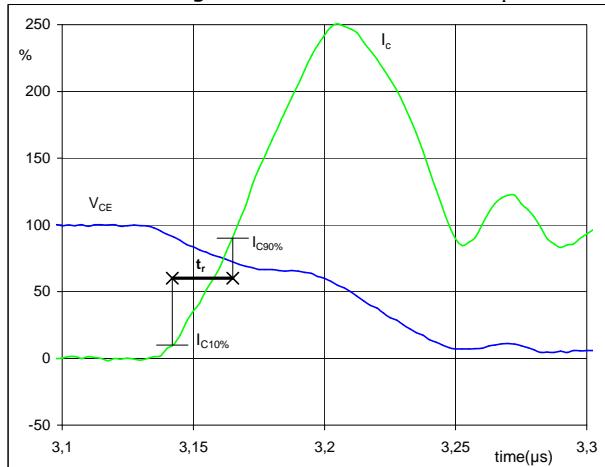
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%) = 700$ V
 $I_C(100\%) = 100$ A
 $t_f = 0,06$ μs

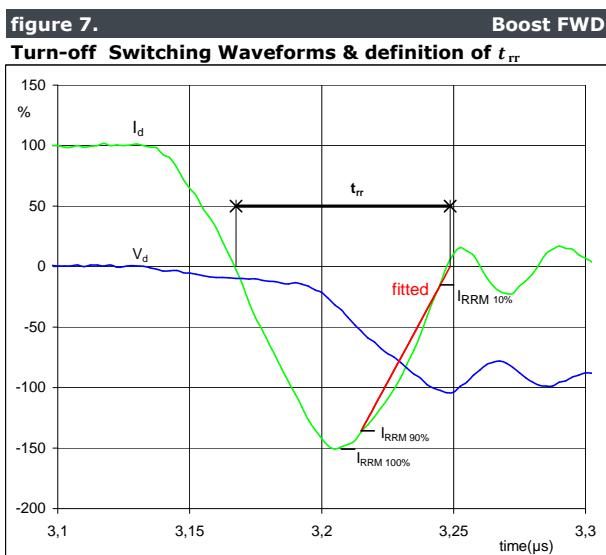
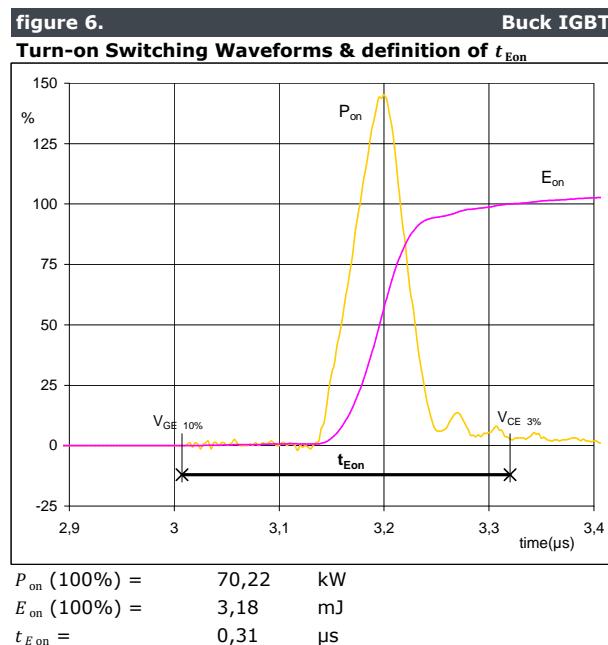
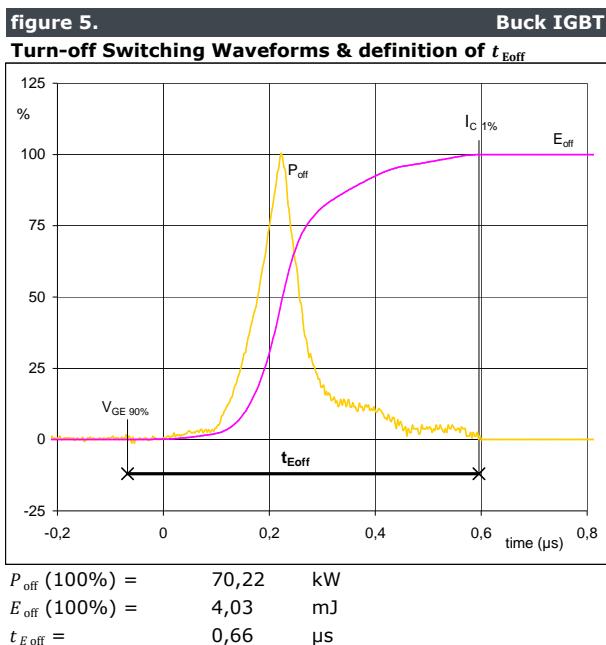
figure 4.**Buck IGBT**

Turn-on Switching Waveforms & definition of t_r



$V_C(100\%) = 700$ V
 $I_C(100\%) = 100$ A
 $t_r = 0,02$ μs

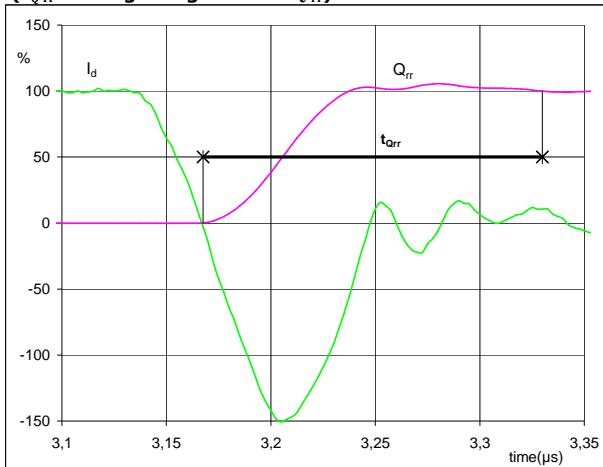
Switching Definitions Buck



Switching Definitions Buck

figure 8.**Boost FWD**

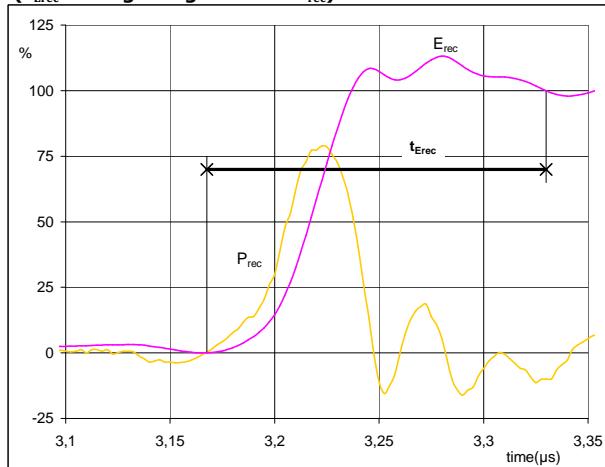
Turn-on Switching Waveforms & definition of t_{Qrr}
 $(t_{Qrr} = \text{integrating time for } Q_{rr})$



I_d (100%) = 100 A
 Q_{rr} (100%) = 7,13 μC
 t_{Qrr} = 0,16 μs

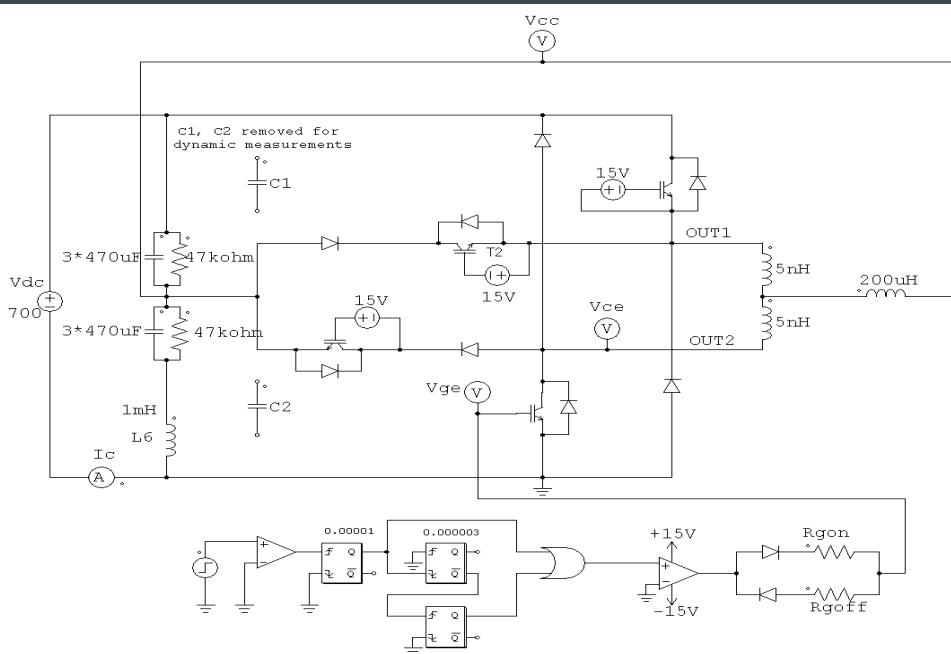
figure 9.**Boost FWD**

Turn-on Switching Waveforms & definition of t_{Erec}
 $(t_{Erec} = \text{integrating time for } E_{rec})$



P_{rec} (100%) = 70,22 kW
 E_{rec} (100%) = 1,01 mJ
 t_{Erec} = 0,16 μs

Buck switching measurement circuit

figure 10.

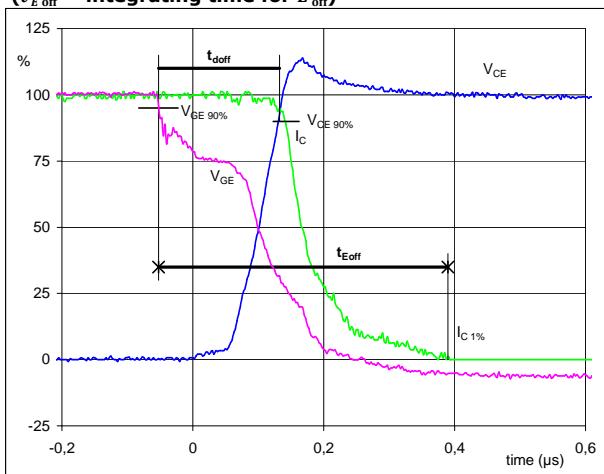
Switching Definitions Boost

General conditions

T_j	= 125 °C
R_{gon}	= 4 Ω
R_{goff}	= 4 Ω

figure 1.**Boost IGBT**

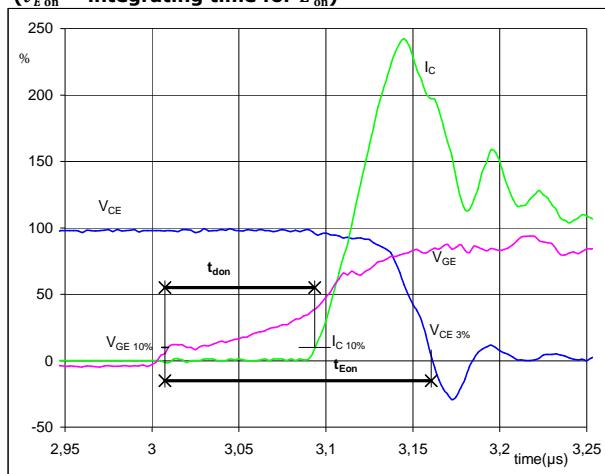
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
 $(t_{Eoff} = \text{integrating time for } E_{off})$



$V_{GE}(0\%) = -15$ V
 $V_{GE}(100\%) = 15$ V
 $V_C(100\%) = 700$ V
 $I_C(100\%) = 100$ A
 $t_{doff} = 0,18$ μs
 $t_{Eoff} = 0,44$ μs

figure 2.**Boost IGBT**

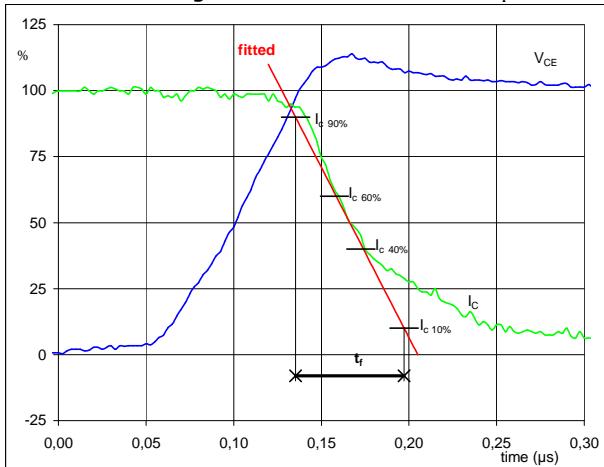
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
 $(t_{Eon} = \text{integrating time for } E_{on})$



$V_{GE}(0\%) = -15$ V
 $V_{GE}(100\%) = 15$ V
 $V_C(100\%) = 700$ V
 $I_C(100\%) = 100$ A
 $t_{don} = 0,10$ μs
 $t_{Eon} = 0,15$ μs

figure 3.**Boost IGBT**

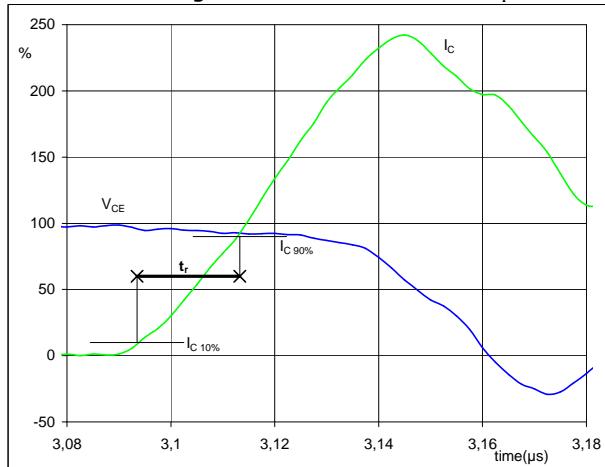
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%) = 700$ V
 $I_C(100\%) = 100$ A
 $t_f = 0,064$ μs

figure 4.**Boost IGBT**

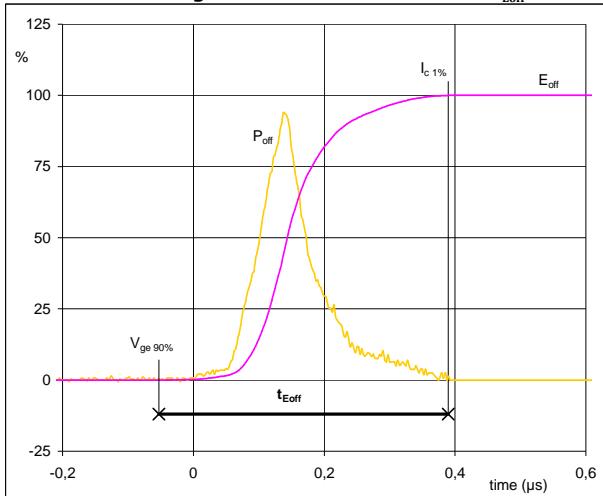
Turn-on Switching Waveforms & definition of t_r



$V_C(100\%) = 700$ V
 $I_C(100\%) = 100$ A
 $t_r = 0,019$ μs

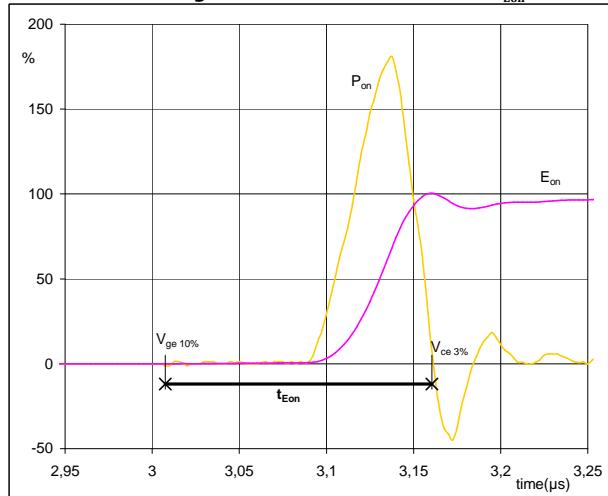
Switching Definitions Boost

figure 5. **Boost IGBT**
Turn-off Switching Waveforms & definition of t_{Eoff}



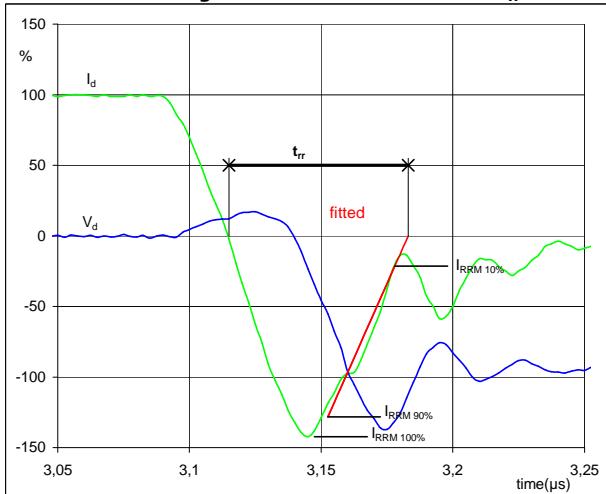
$P_{off} (100\%) =$ 69,93 kW
 $E_{off} (100\%) =$ 3,32 mJ
 $t_{Eoff} =$ 0,44 μs

figure 6. **Boost IGBT**
Turn-on Switching Waveforms & definition of t_{Eon}



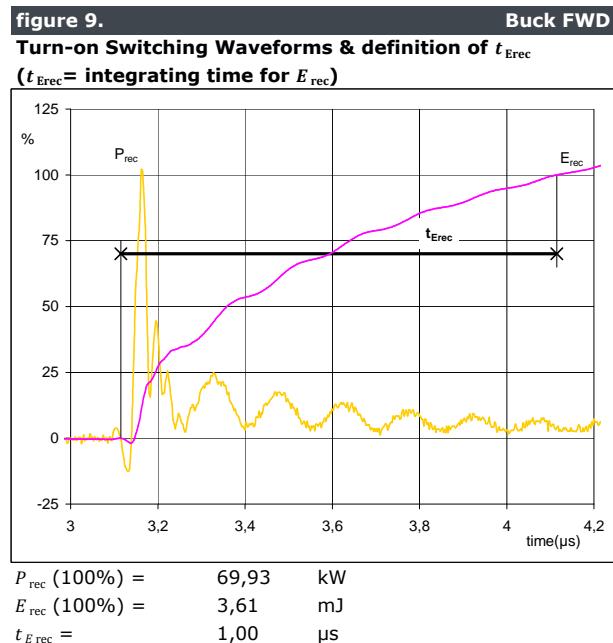
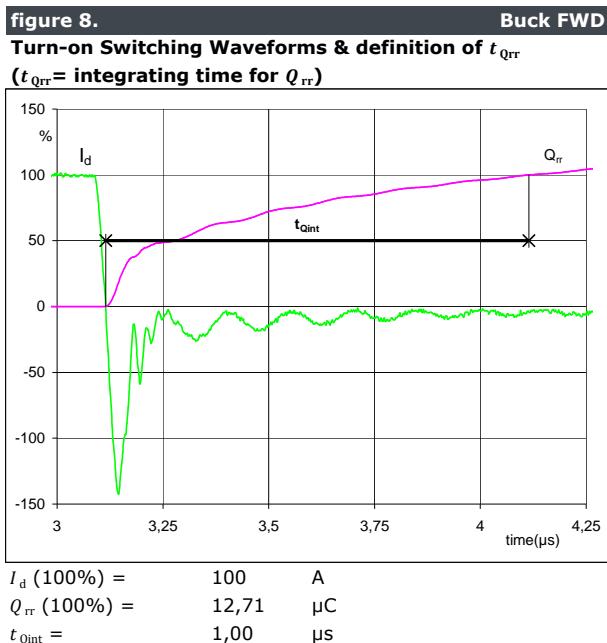
$P_{on} (100\%) =$ 69,9279 kW
 $E_{on} (100\%) =$ 1,52 mJ
 $t_{Eon} =$ 0,18 μs

figure 7. **Buck FWD**
Turn-off Switching Waveforms & definition of t_{rr}

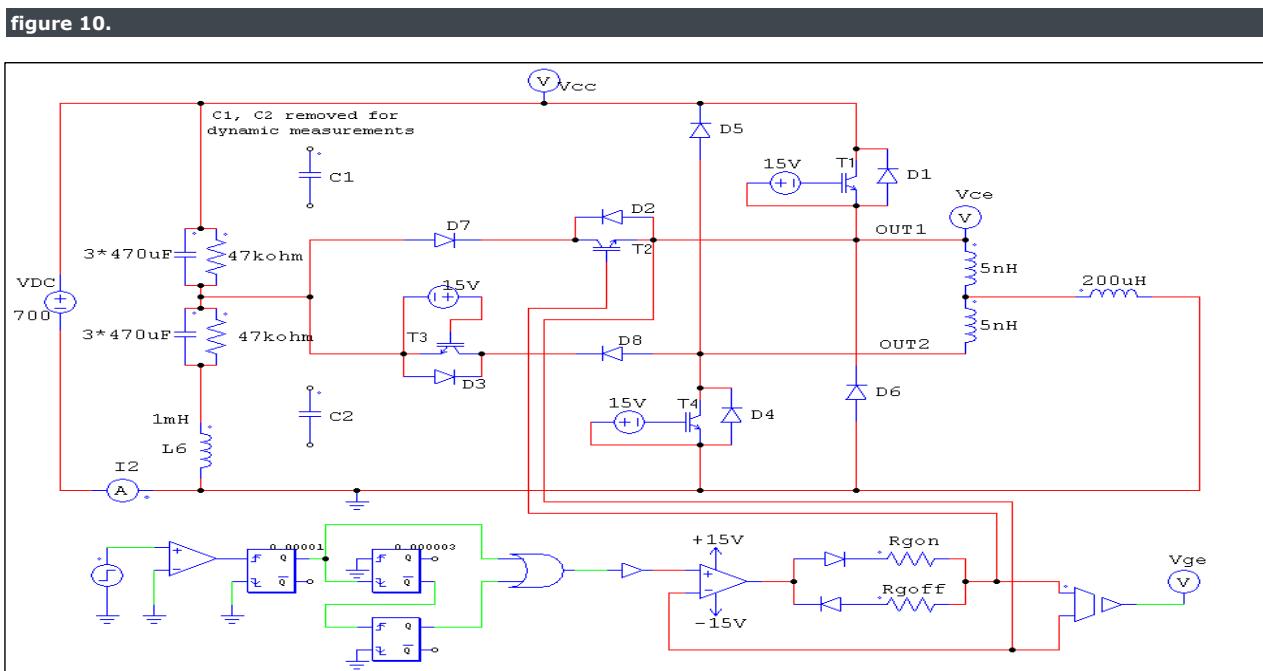


$V_d (100\%) =$ 700 V
 $I_d (100\%) =$ 100 A
 $I_{RRM} (100\%) =$ -142 A
 $t_{rr} =$ 0,07 μs

Switching Definitions Boost



Boost switching measurement circuit





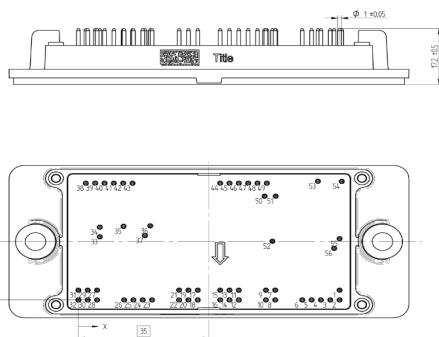
Vincotech

30-FT12NMA160SH-M669F08

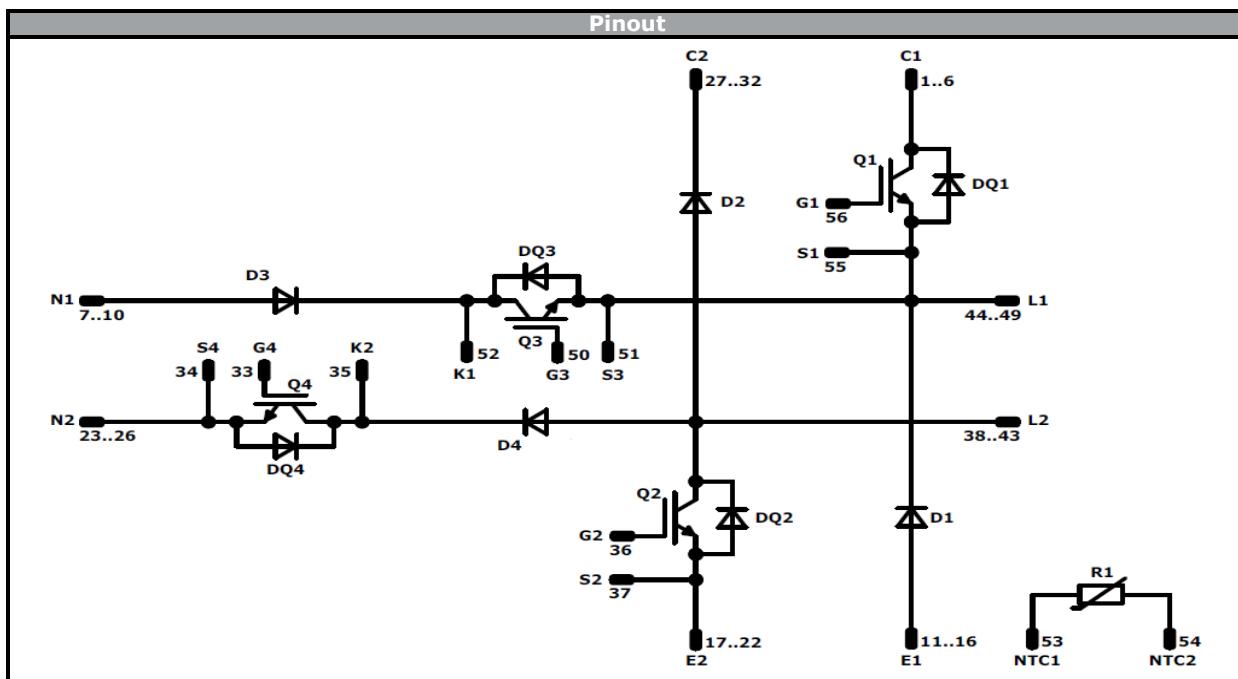
datasheet

Ordering Code & Marking							
Version				Ordering Code			
without thermal paste 13mm housing				30-FT12NMA160SH-M669F08			
				Text	Name	Date code	UL & VIN
					NN-NNNNNNNNNNNNNN-YYYYYY	WWYY	UL VIN
				Datamatrix	Type&Ver	Lot number	Lot
					Serial	Date code	Serial
					TTTTTTVV	LLLLL	SSSS
						WWYY	

Outline							
Pin table [mm]				Pin table [mm]			
Pin	X	Y	Function	Pin	X	Y	Function
1	70	3	C1	29	2,5	3	C2
2	70	0	C1	30	2,5	0	C2
3	67,5	0	C1	31	0	3	C2
4	65	0	C1	32	0	0	C2
5	62,5	0	C1	33	5,75	19,45	G4
6	60	0	C1	34	5,75	22,45	S4
7	52,75	3	N1	35	12,1	22,7	K2
8	52,75	0	N1	36	19,25	22,85	G2
9	50,25	3	N1	37	17,85	19,85	S2
10	50,25	0	N1	38	2	36	L2
11	43	3	E1	39	4,5	36	L2
12	43	0	E1	40	7	36	L2
13	40,5	3	E1	41	9,5	36	L2
14	40,5	0	E1	42	12	36	L2
15	38	3	E1	43	14,5	36	L2
16	38	0	E1	44	38	36	L1
17	32	3	E2	45	40,5	36	L1
18	32	0	E2	46	43	36	L1
19	29,5	3	E2	47	45,5	36	L1
20	29,5	0	E2	48	48	36	L1
21	27	3	E2	49	50,5	36	L1
22	27	0	E2	50	49,9	32	G3
23	19,75	0	N2	51	52,9	32	S3
24	17,25	0	N2	52	52	18,1	K1
25	14,75	0	N2	53	64,2	36,6	NTC
26	12,25	0	N2	54	70,6	36,55	NTC
27	5	3	C2	55	70	18,9	S1
28	5	0	C2	56	68,55	15,9	G1



Tolerance of positions: +/-0.5mm at the end of pins.
Dimension or coordinate axis is only offset without tolerance.

**Identification**

ID	Component	Voltage	Current	Function	Comment
Q1,Q2	IGBT	1200 V	160 A	Buck Switch	
DQ1,DQ2	FWD	1200 V	7 A	Buck Inverse Diode	
D3,D4	FWD	600 V	120 A	Buck Diode	
Q3,Q4	IGBT	600 V	120 A	Boost Switch	
D1,D2	FWD	1200 V	60 A	Boost Diode	
DQ3,DQ4	FWD	600 V	50 A	Boost Inverse Diode	
R1	NTC			Thermistor	



Vincotech

30-FT12NMA160SH-M669F08

datasheet

Packaging instruction		>SPQ	Standard	<SPQ	Sample
Standard packaging quantity (SPQ)	36				

Handling instruction
Handling instructions for <i>flow</i> 2 packages see vincotech.com website.

Package data
Package data for <i>flow</i> 2 packages see vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website. 

Document No.:	Date:	Modification:	Pages
30-FT12NMA160SH-M669F08-D4-14	13 Jun. 2017	New design, packing unit number	All

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.